

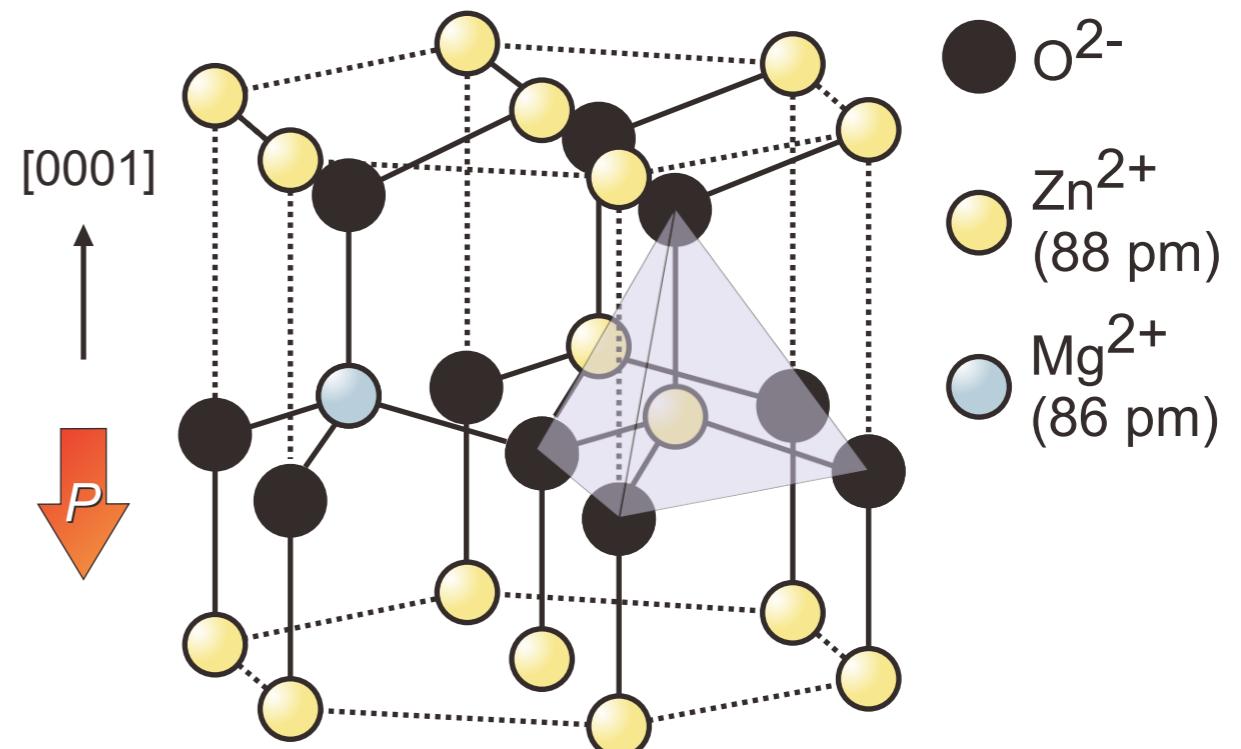
High Purity Synthesis of Binary Oxides

Joseph Falson

Caltech

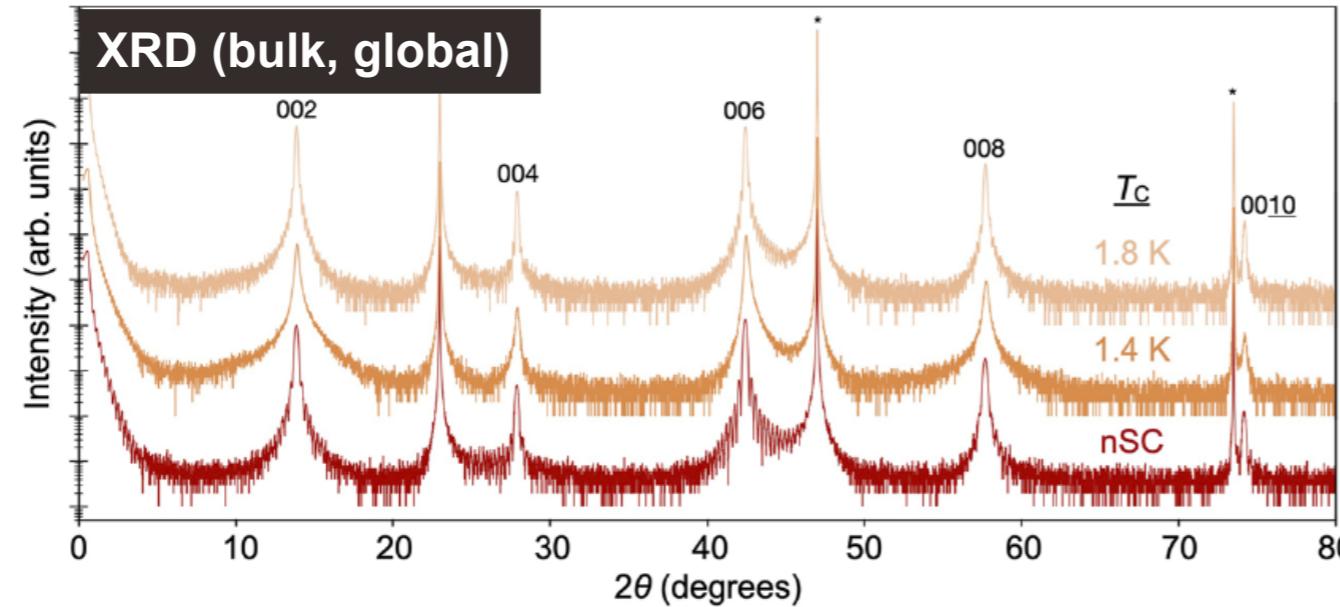
Talk outline

- What defines high purity?
- Motivation and background
- MBE introduction
- Substrate preparation
- Band gap engineering
- Growth Parameters
- Interfacial conductivity
- Impurity sources
- Future perspectives

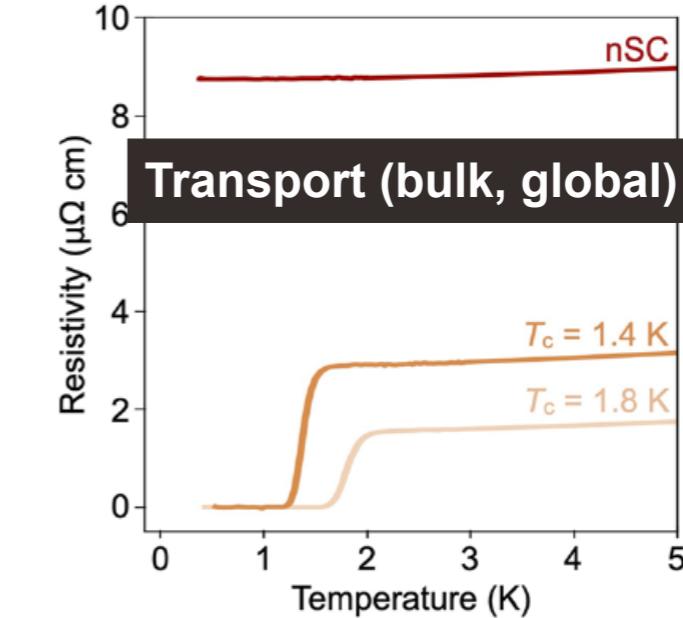


What defines high purity?

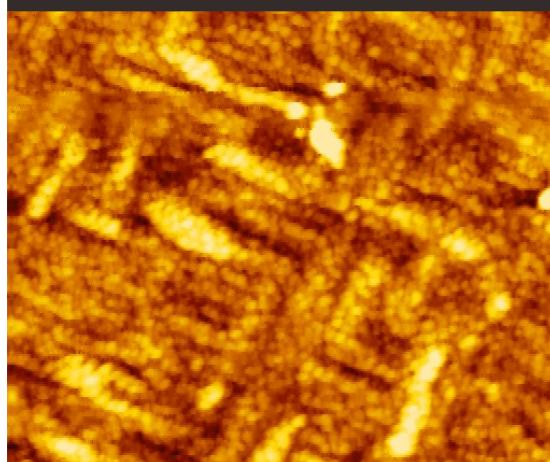
$\text{Sr}_2\text{RuO}_4/(110)\text{NdGaO}_3$



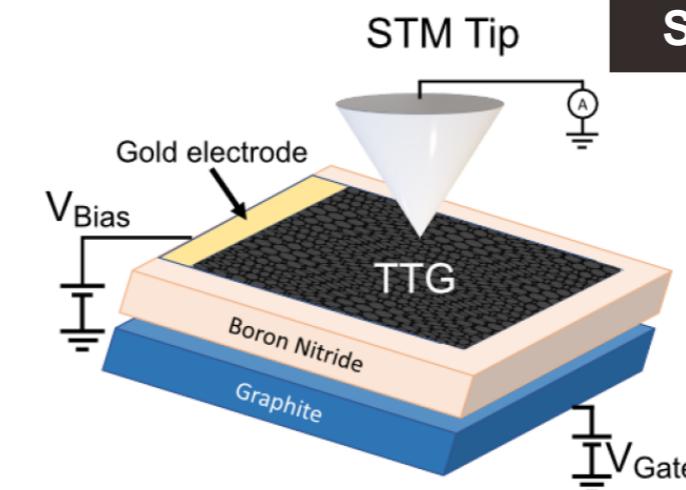
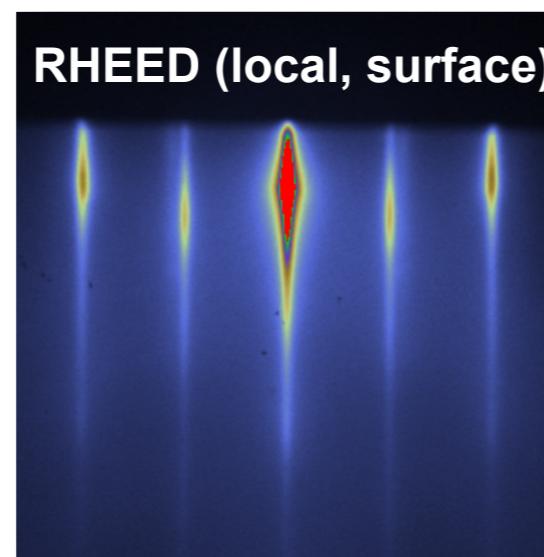
B. Goodge, ... D.G Schlom, *APL Mater.* **10**, 041114 (2022)



AFM (local, surface)

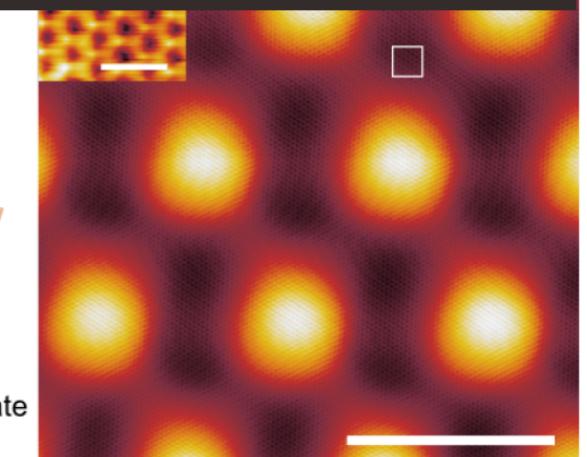


RHEED (local, surface)

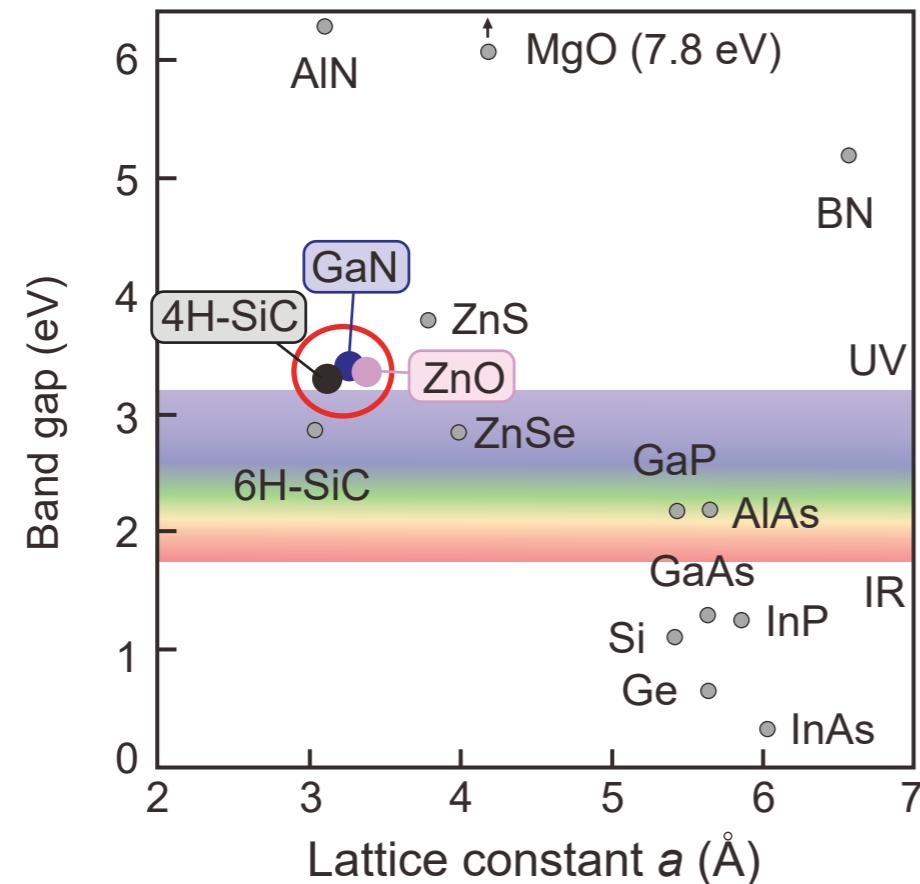


H. Kim arXiv: 2109.12127

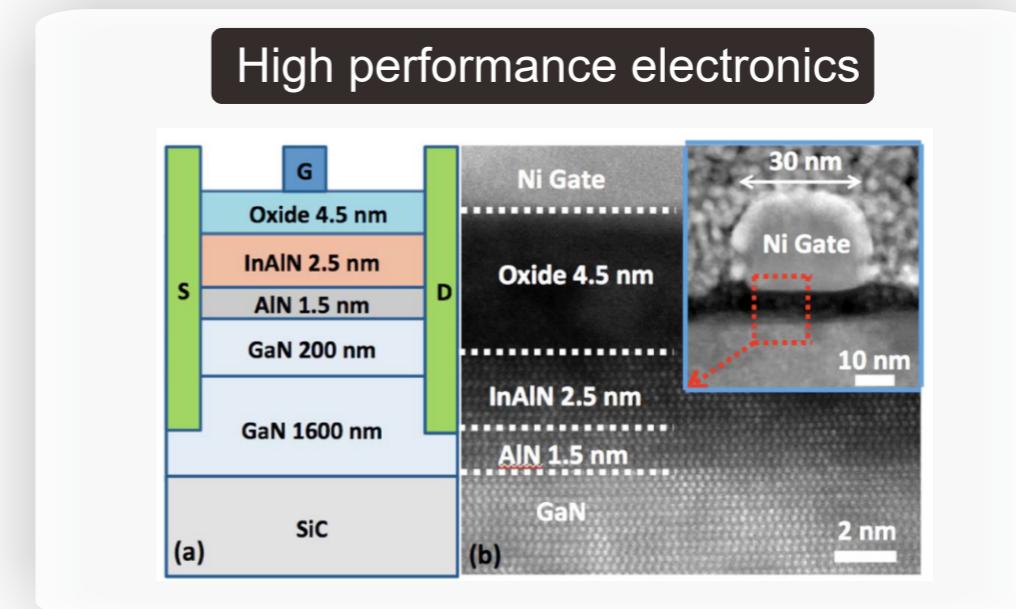
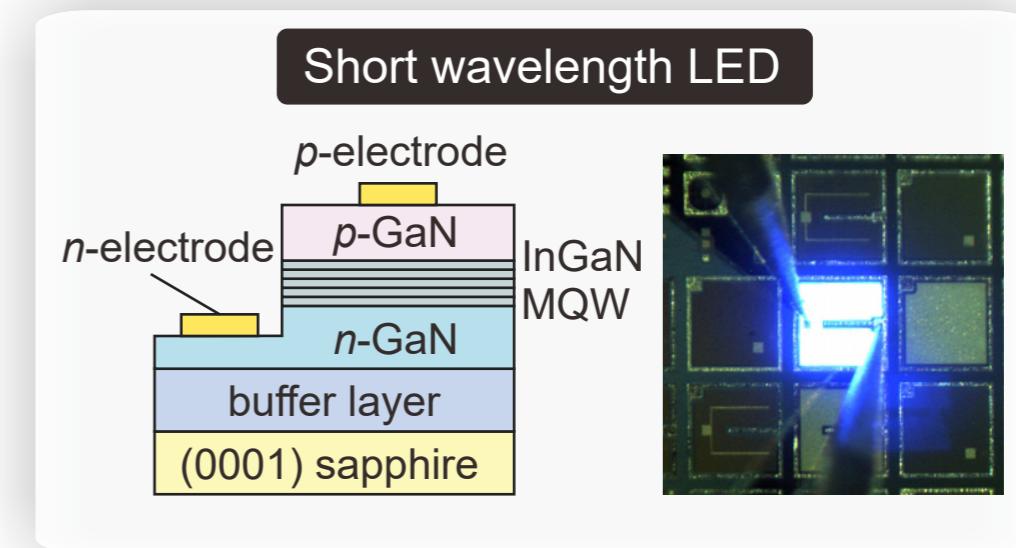
STM (very local, surface)



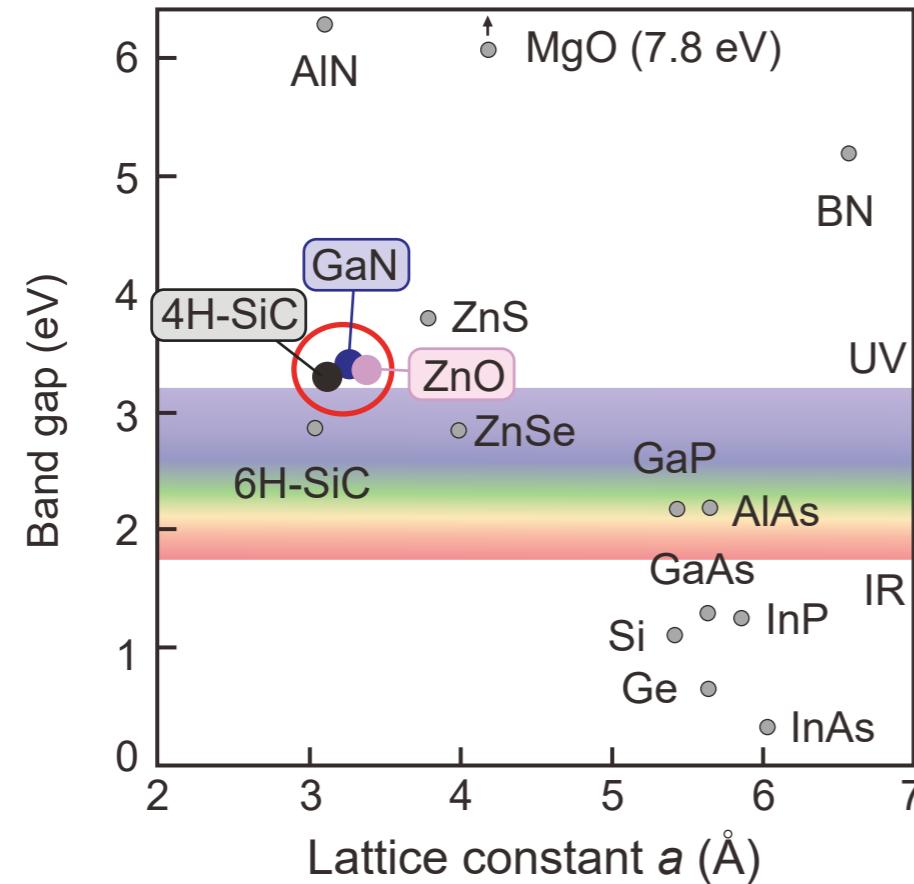
Wide band gap materials



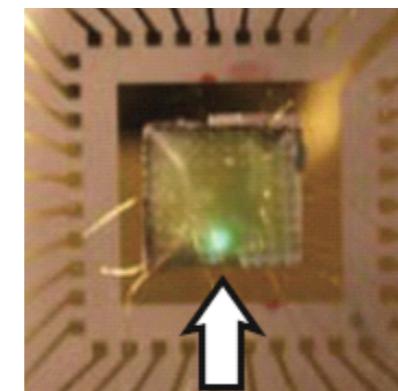
	<u>Breakdown field</u>	<u>Saturation drift velocity</u>
Si:	0.3×10^6 V/cm	1×10^7 cm/s
4H-SiC:	3.0×10^6 V/cm	2×10^7 cm/s
GaN:	3.5×10^6 V/cm	2.5×10^7 cm/s



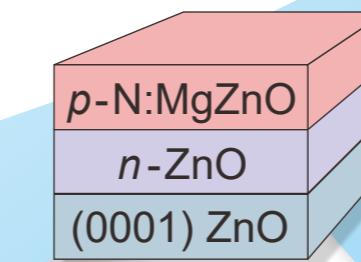
A brief history of ZnO



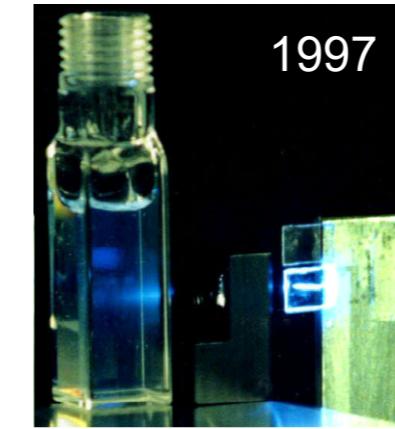
2010 MBE
UV LED &
Green phosphor
Applied Physics Letters,
97, 013501 (2010).



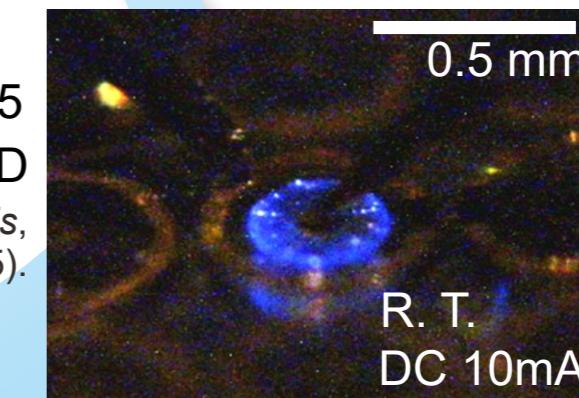
optics



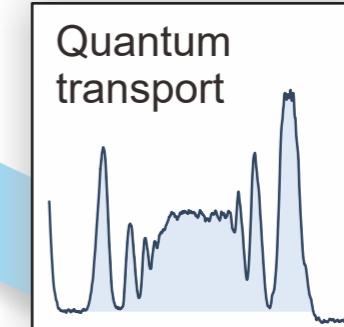
2DES



1997
Stimulated excitonic emission
Solid State Communications,
103, 459 (1997).



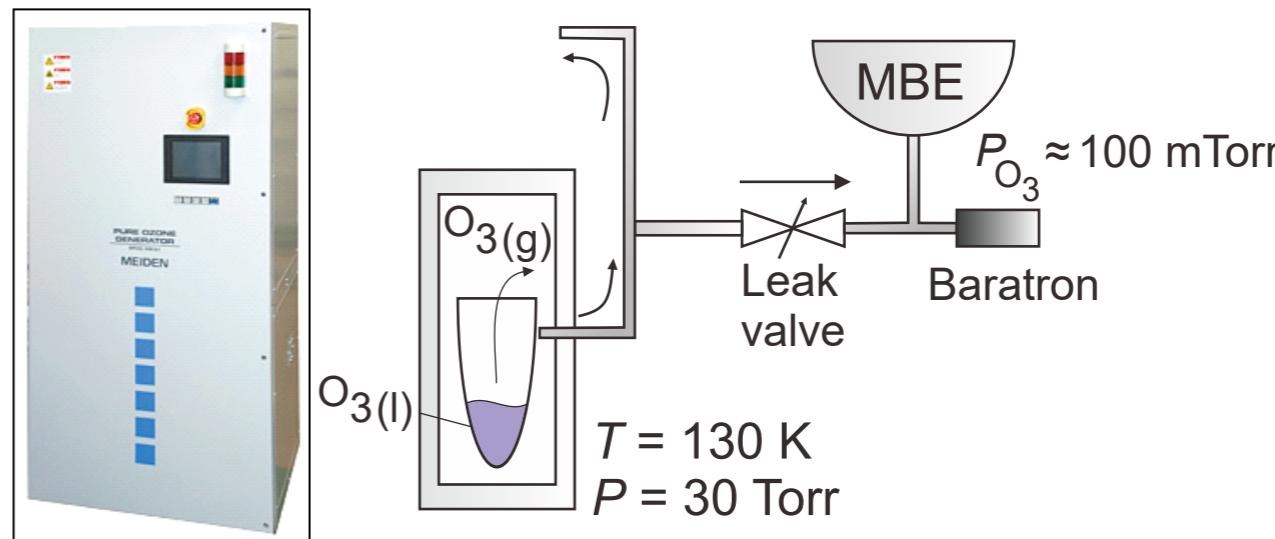
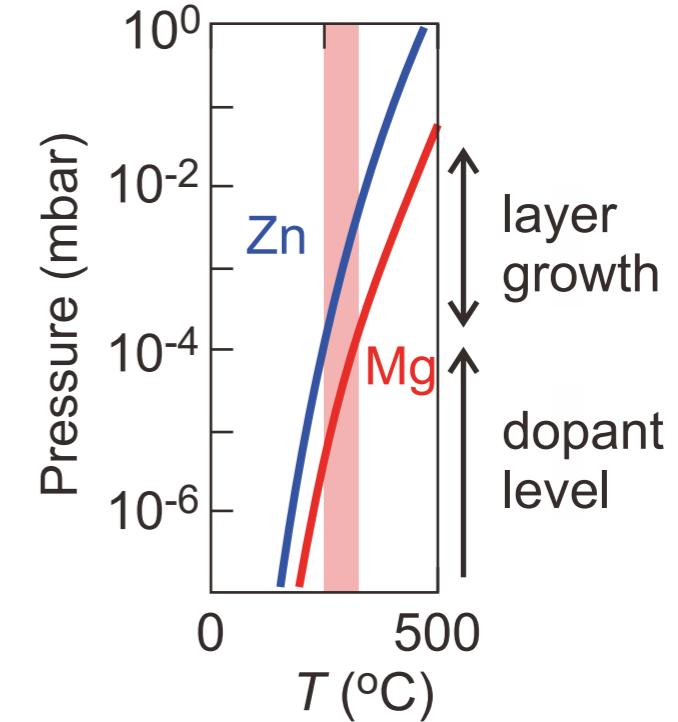
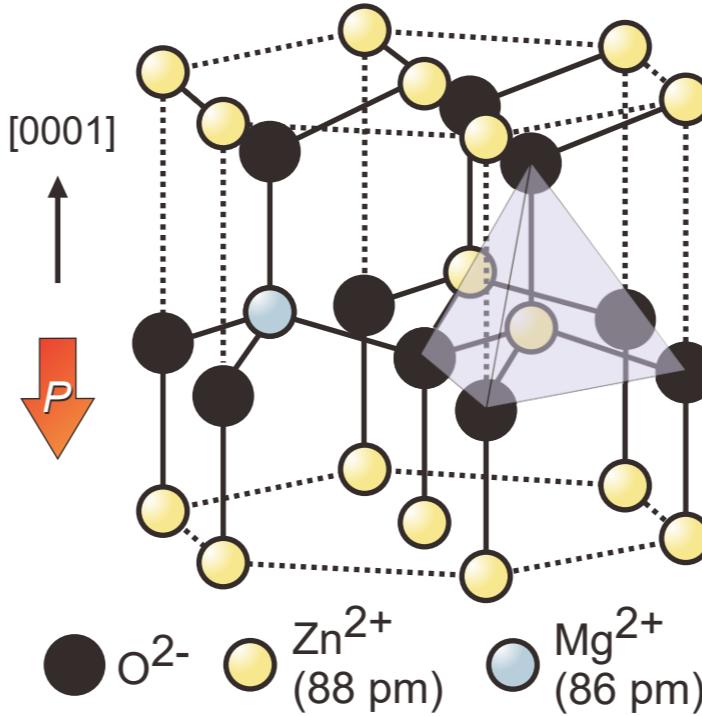
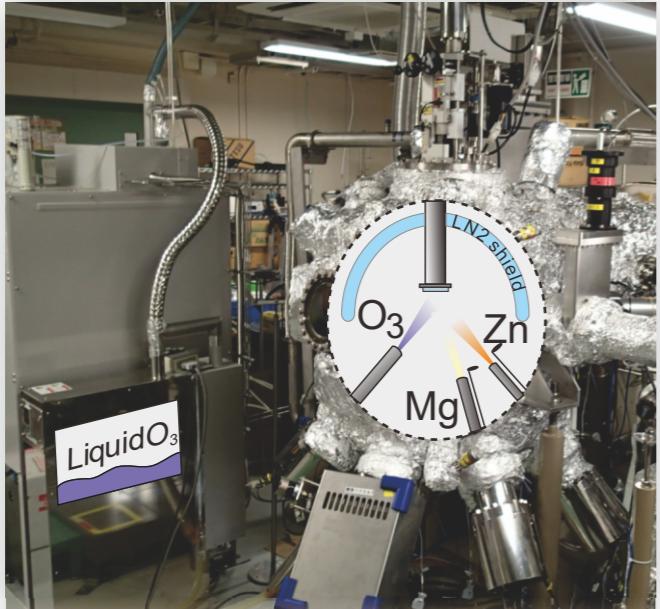
2005
Blue LED
Nature Materials,
4, 42 (2005).



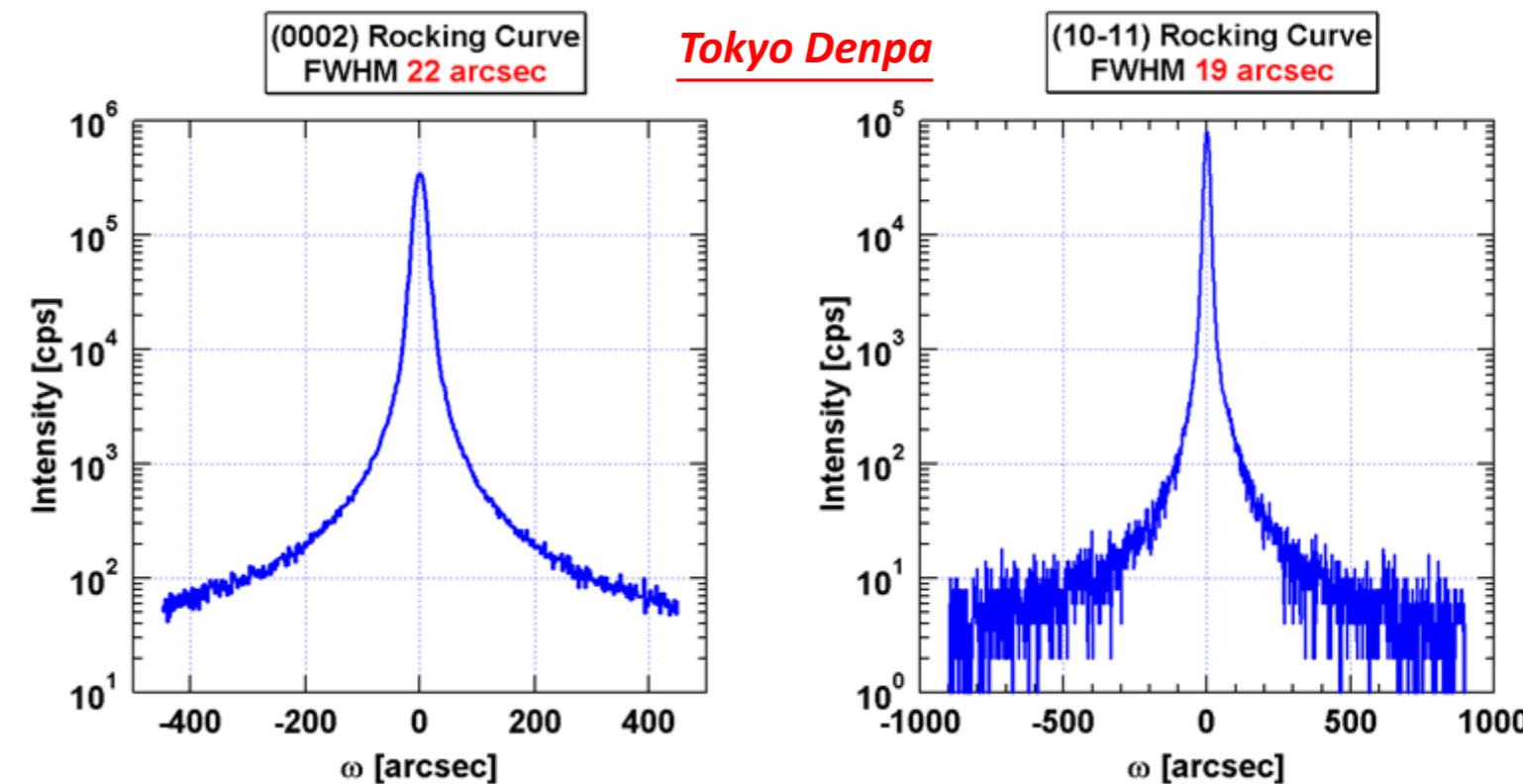
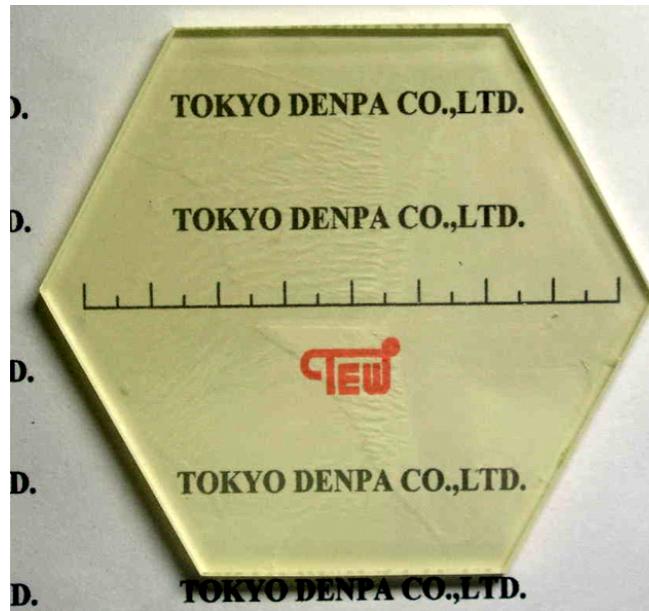
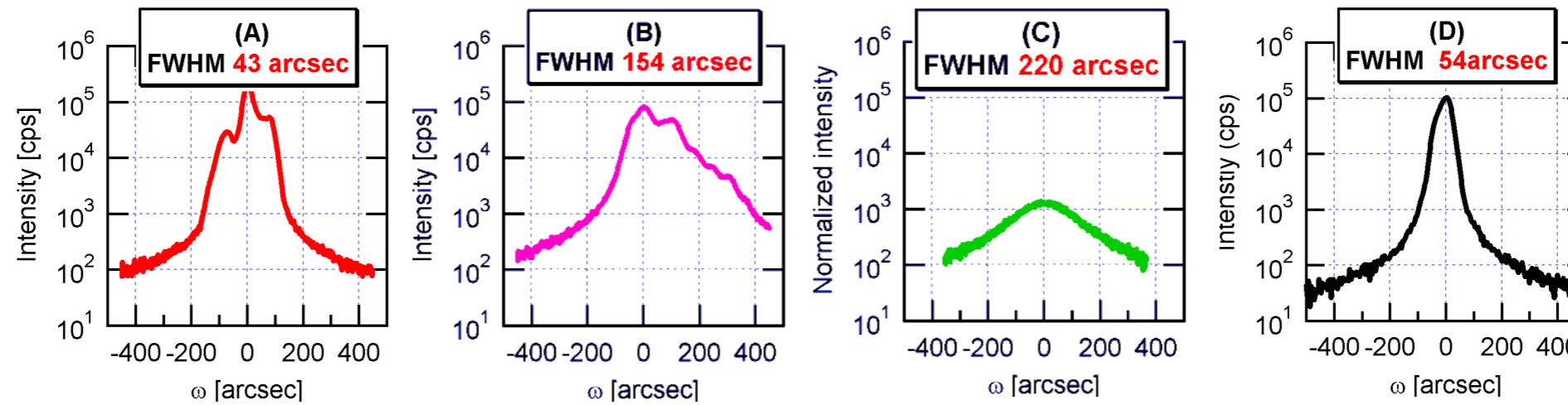
Outline of ZnO MBE

JF and M. Kawasaki.,
Rep. Prog. Phys. 81, 056501 (2018).

5



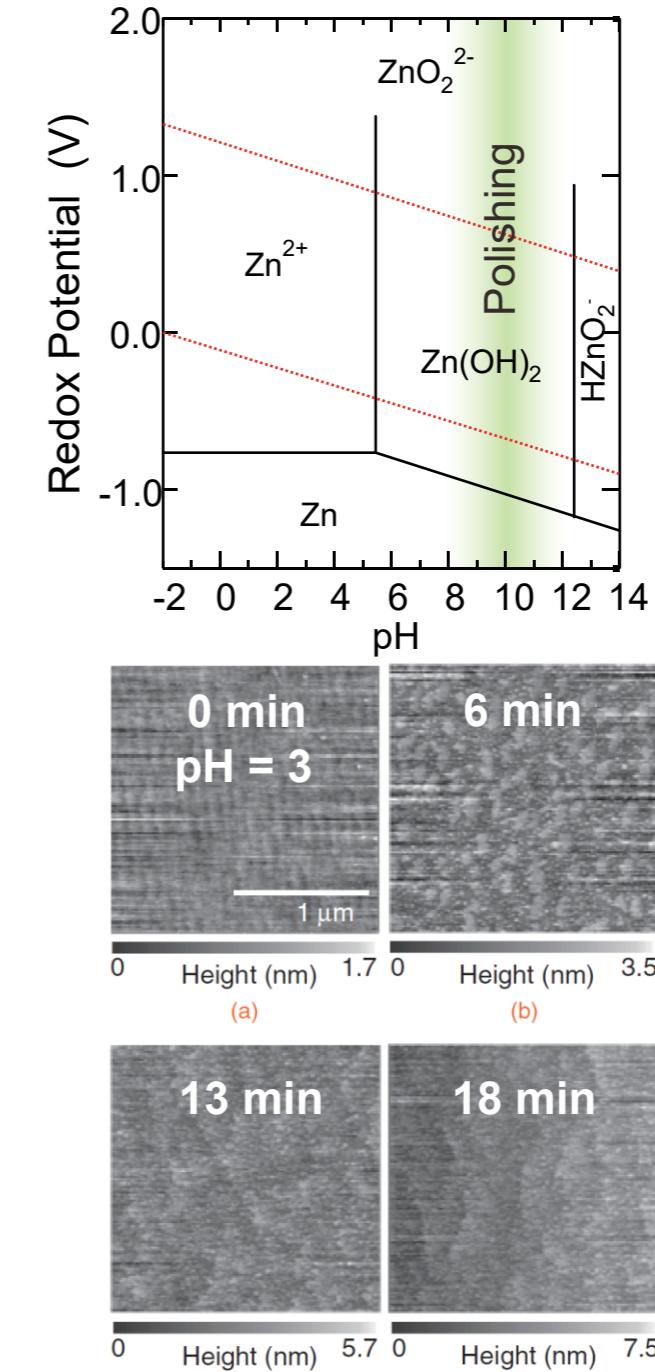
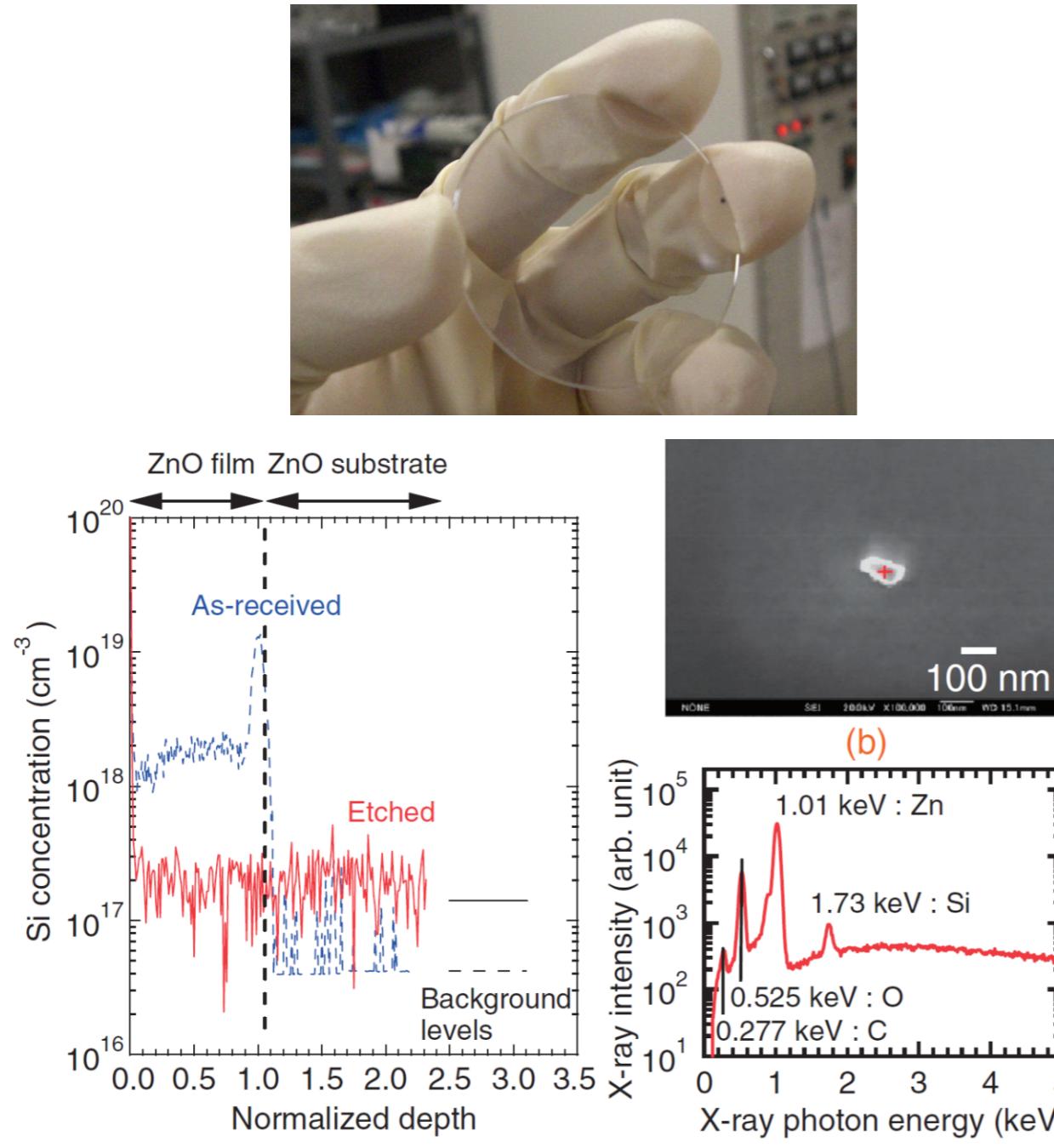
Substrate crystallinity



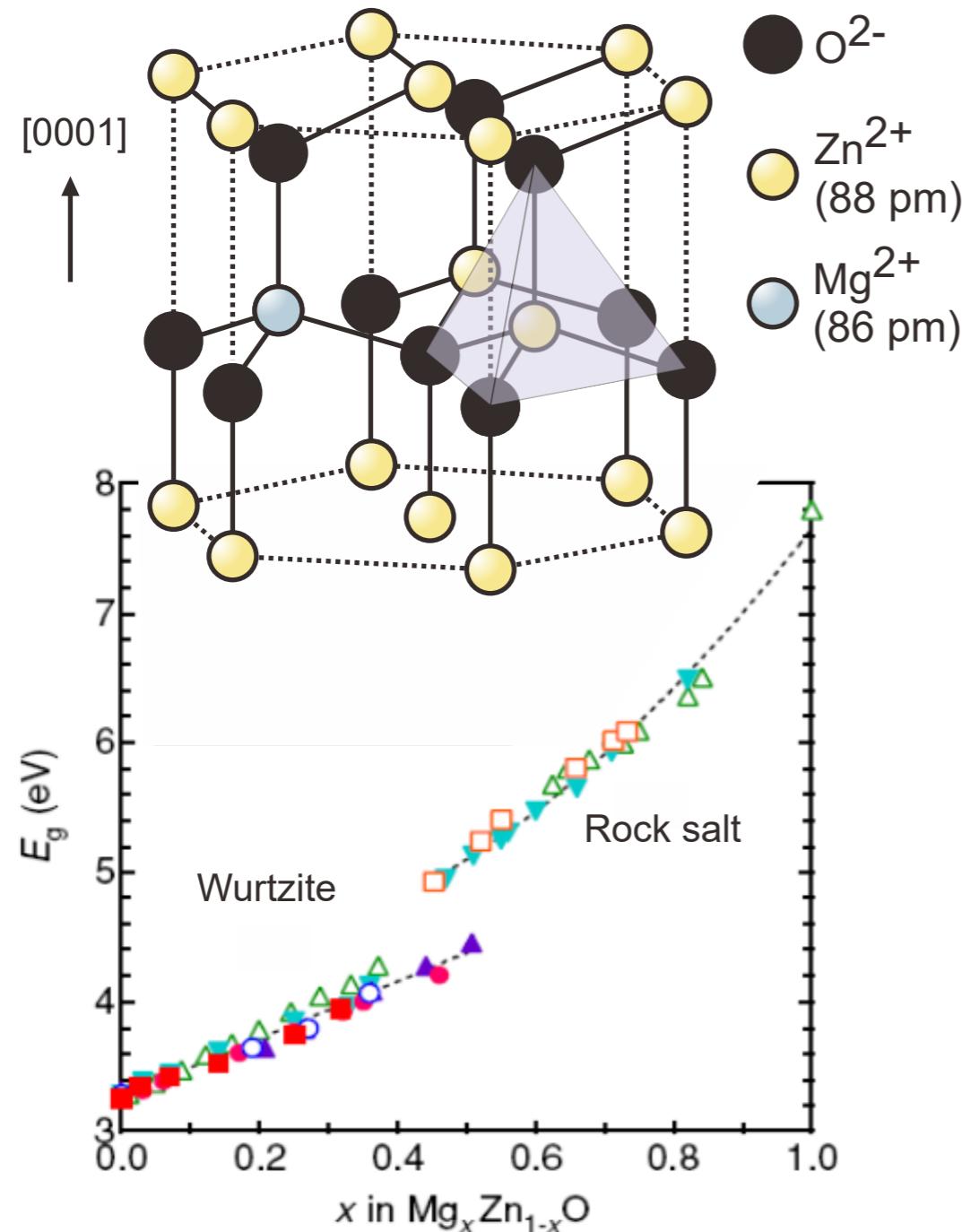
ZnO substrate preparation

S. Akasaka, et al.,
Applied Physics Express 4, 035701 (2011)

7

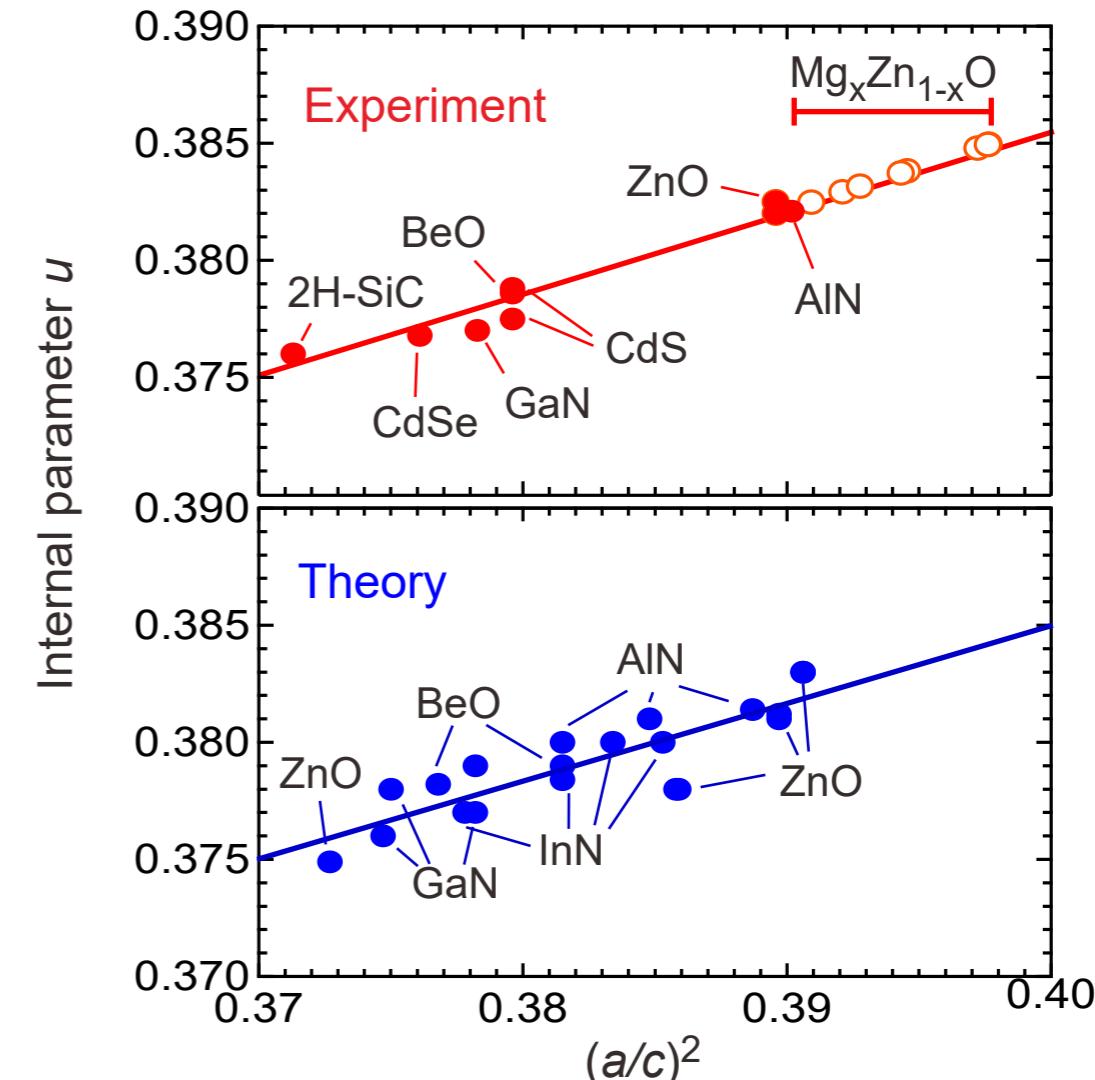


Band and structure engineering



$$u = \frac{a^2}{3c^2} + \frac{1}{4}$$

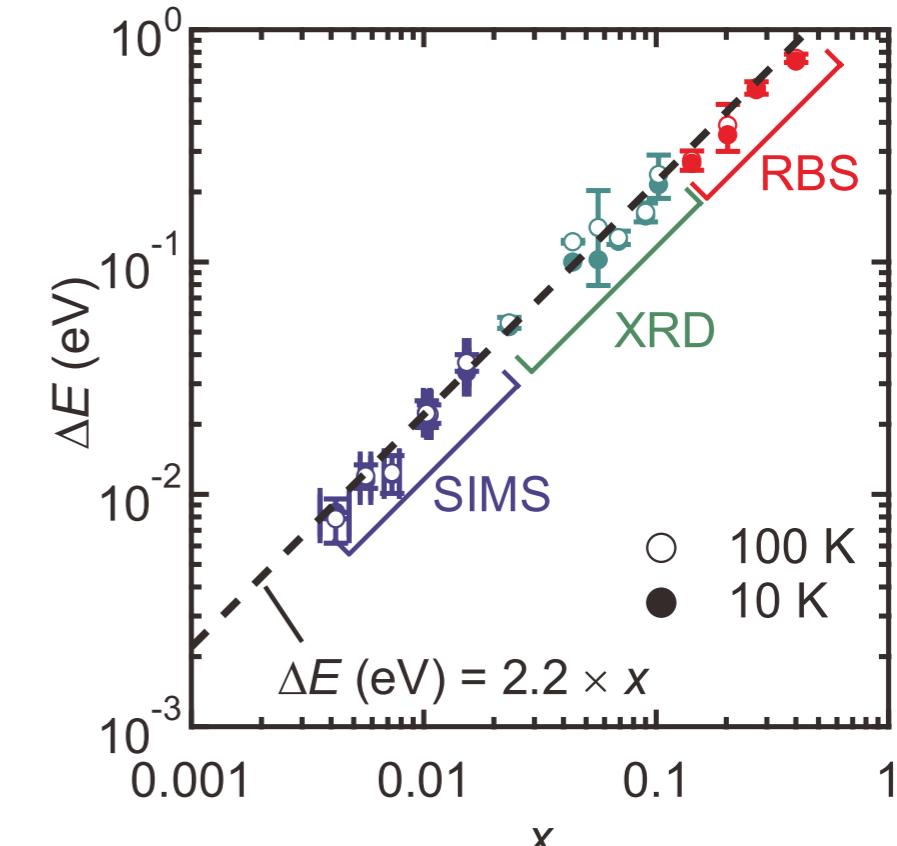
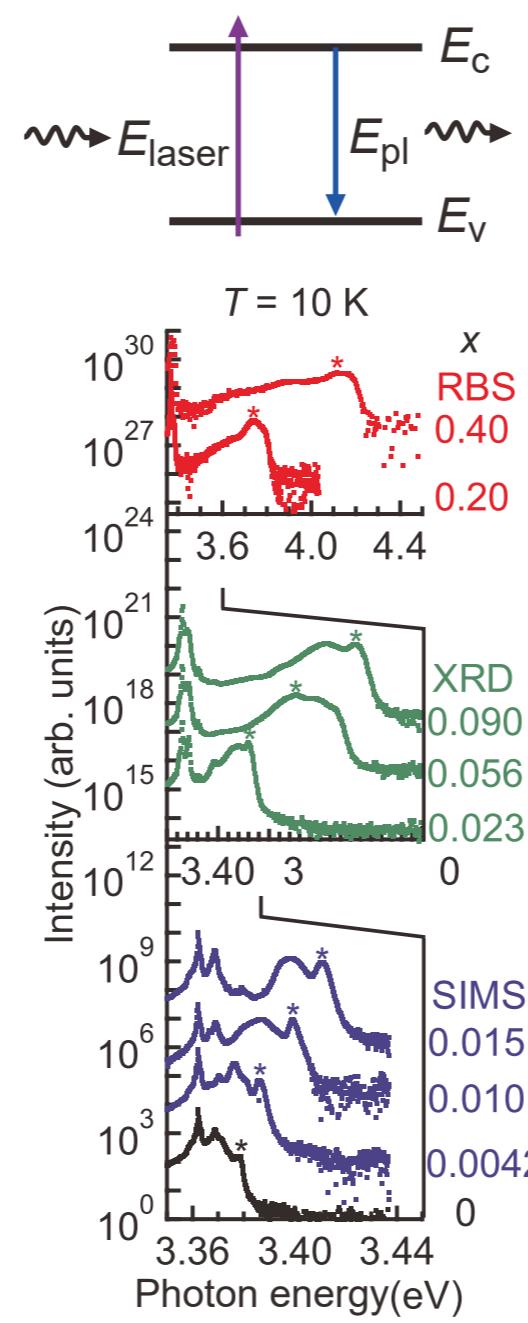
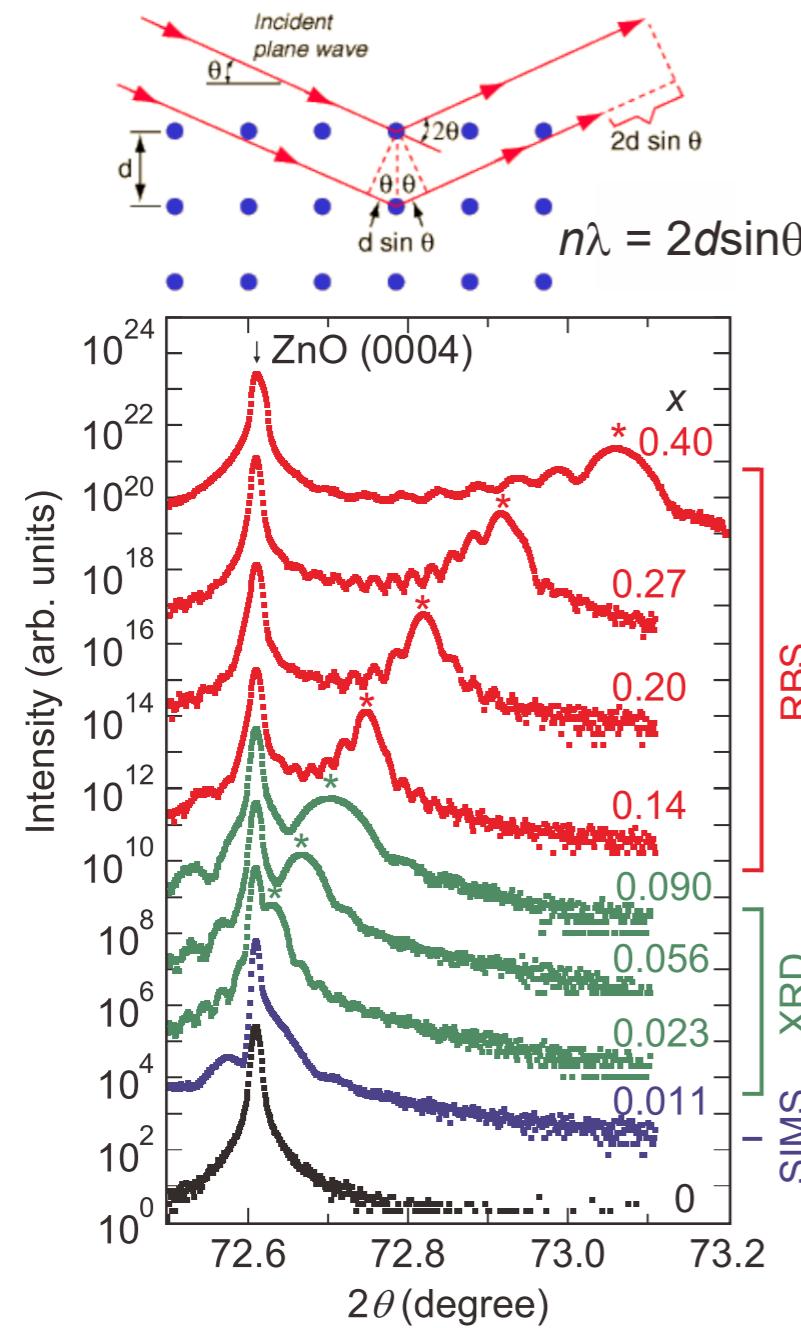
H. Schulz et al,
Solid State Commun.
32, 783 (1979).



Epitaxial Mg alloying

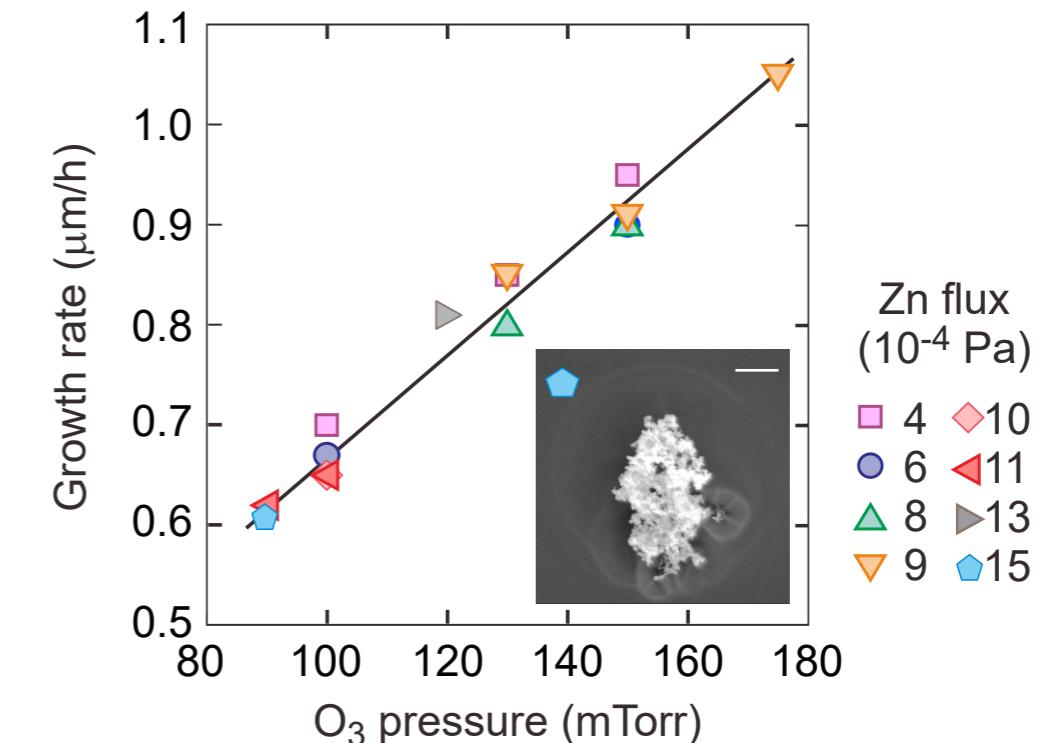
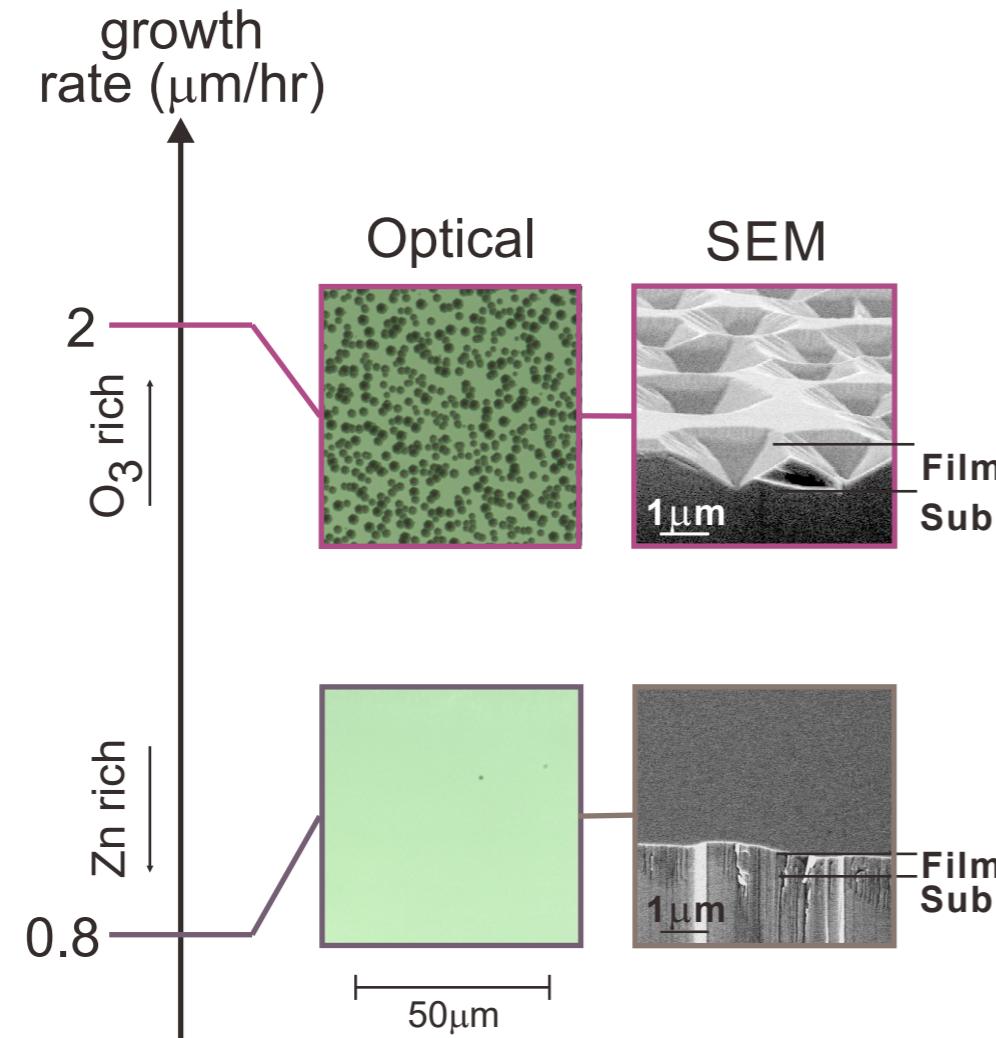
Y. Kozuka, et al.,
Journal of Applied Physics 112, 043515 (2012).

9



Flux ratios: surface morphology

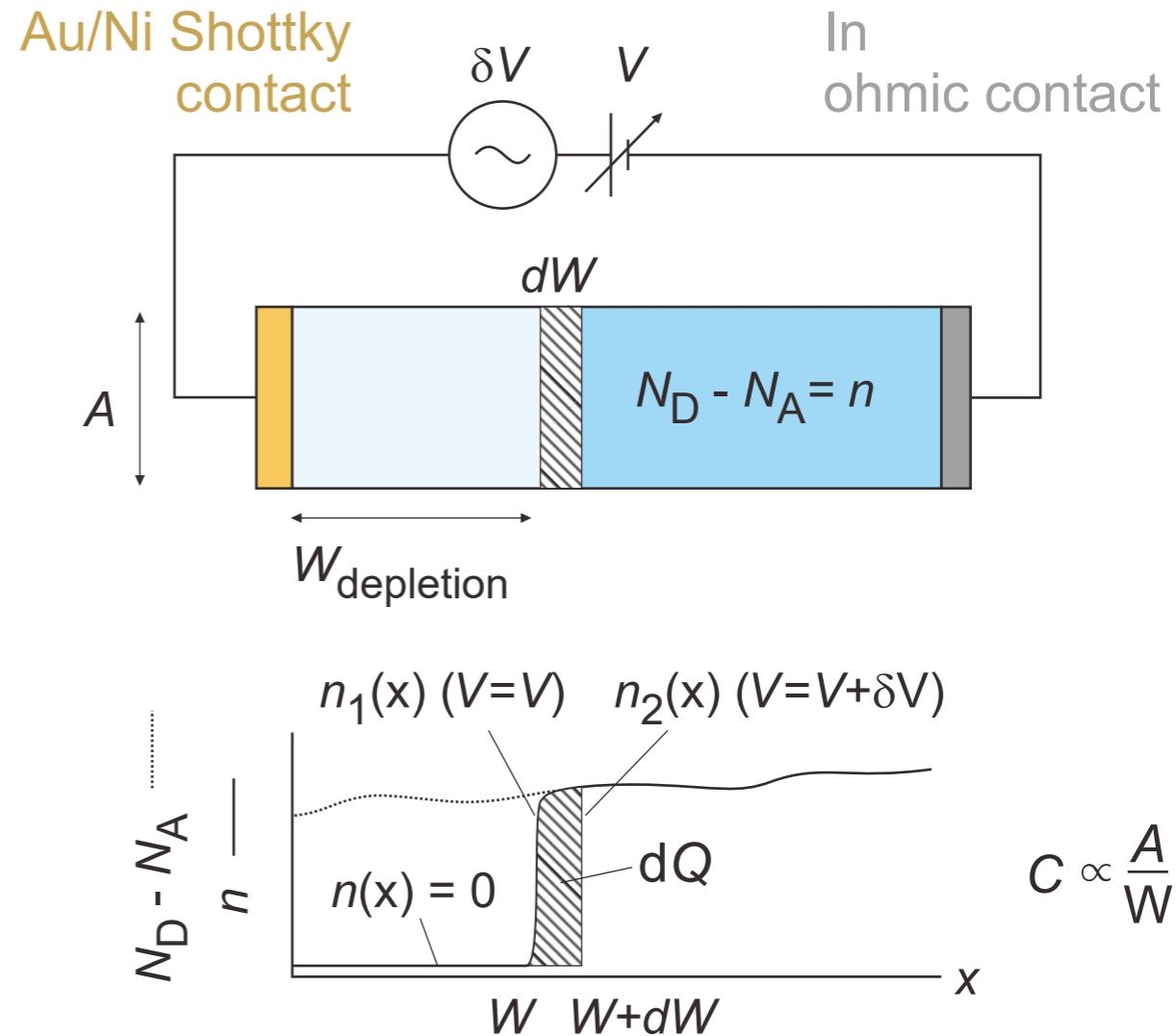
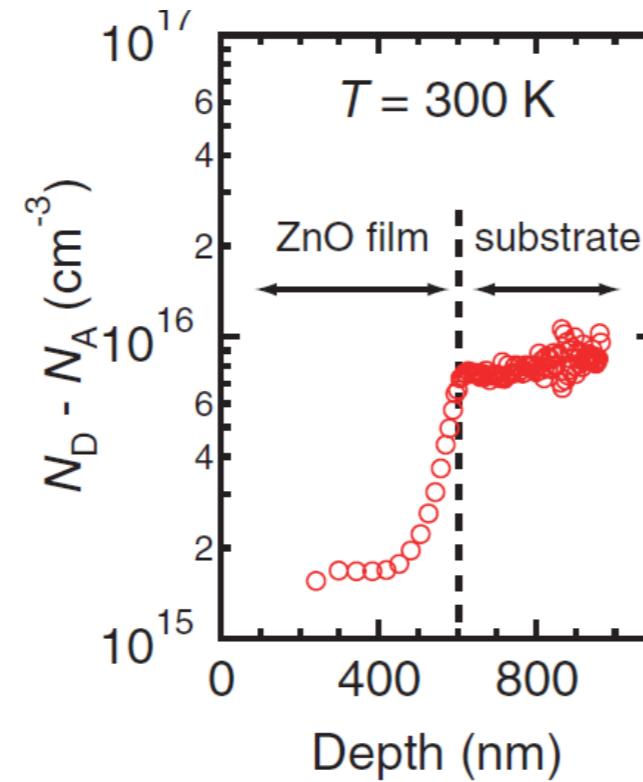
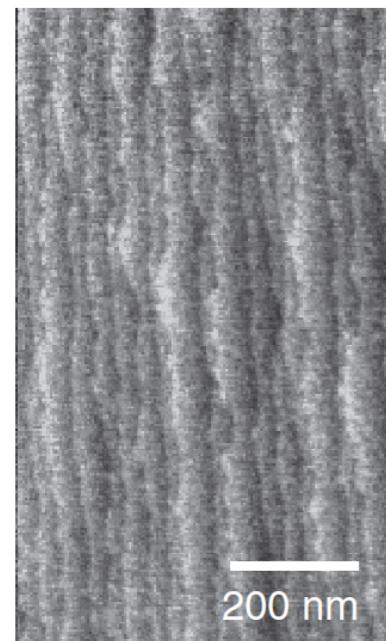
Falson, et al.,
Scientific reports 6, 26598 (2016).



Residual carrier density

S. Akasaka, et al.,
Applied Physics Express 4 035701 (2011).

11



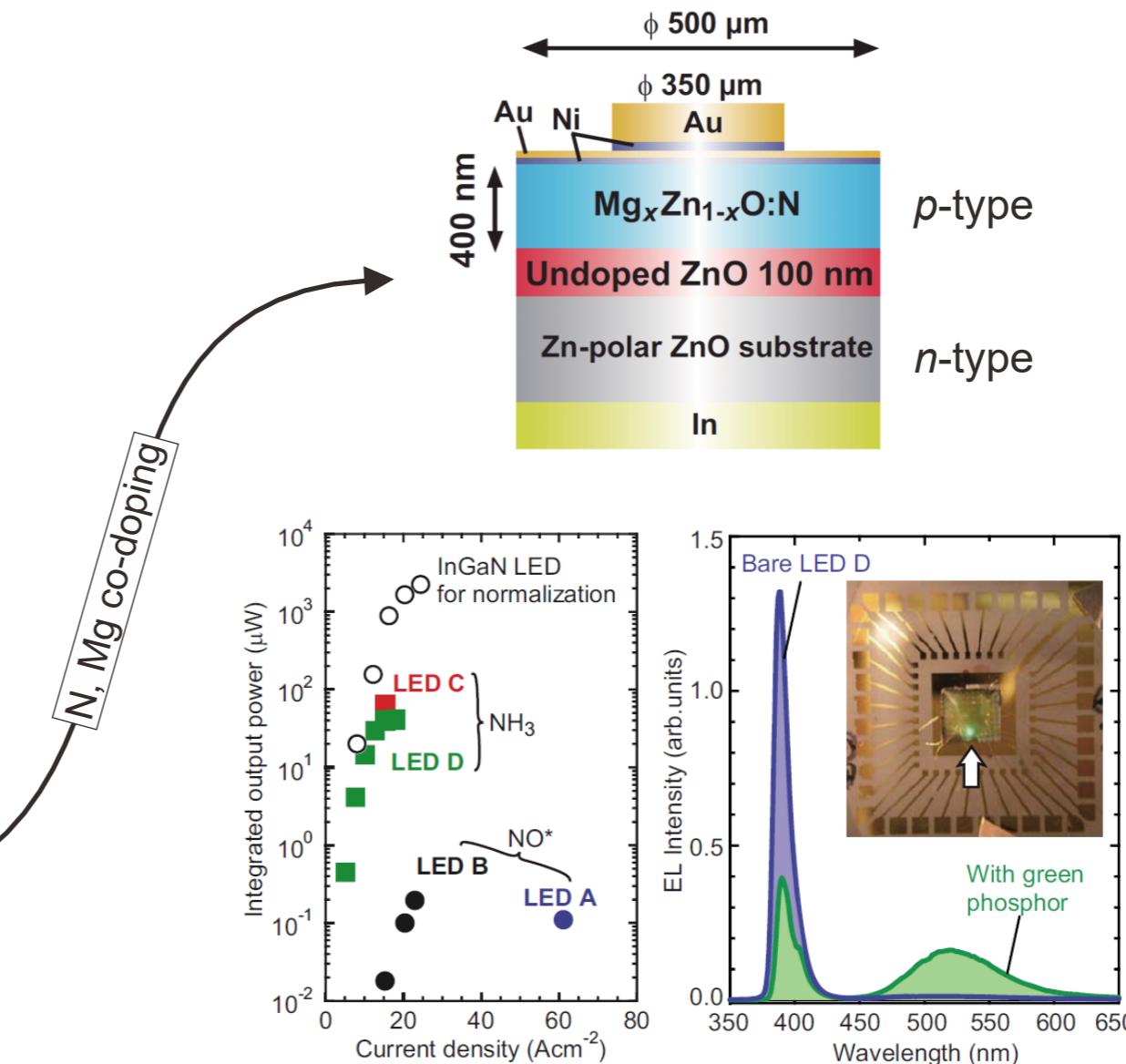
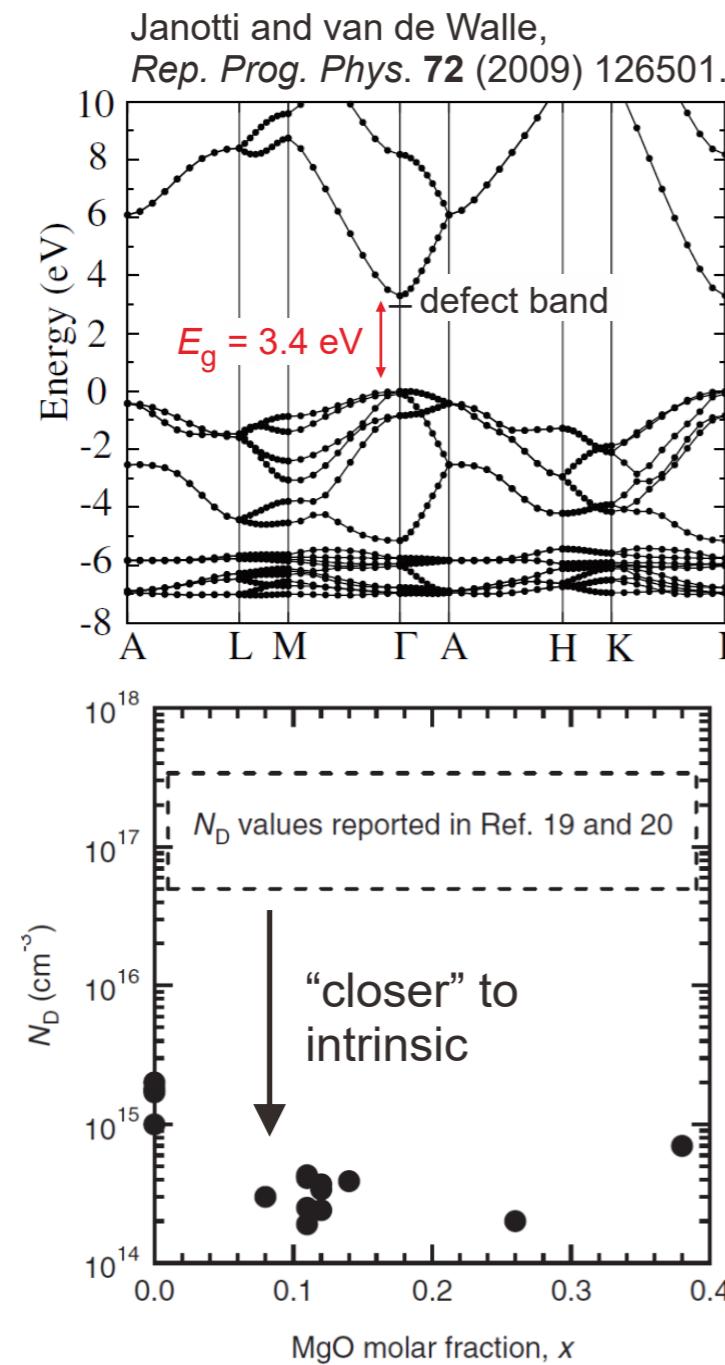
See:
D. Schroder, Semiconductor Material and
Device Characterization (2005)

p-n junctions

S. Akasaka, et al.,
Appl. Phys. Express
 3, 071101 (2010).

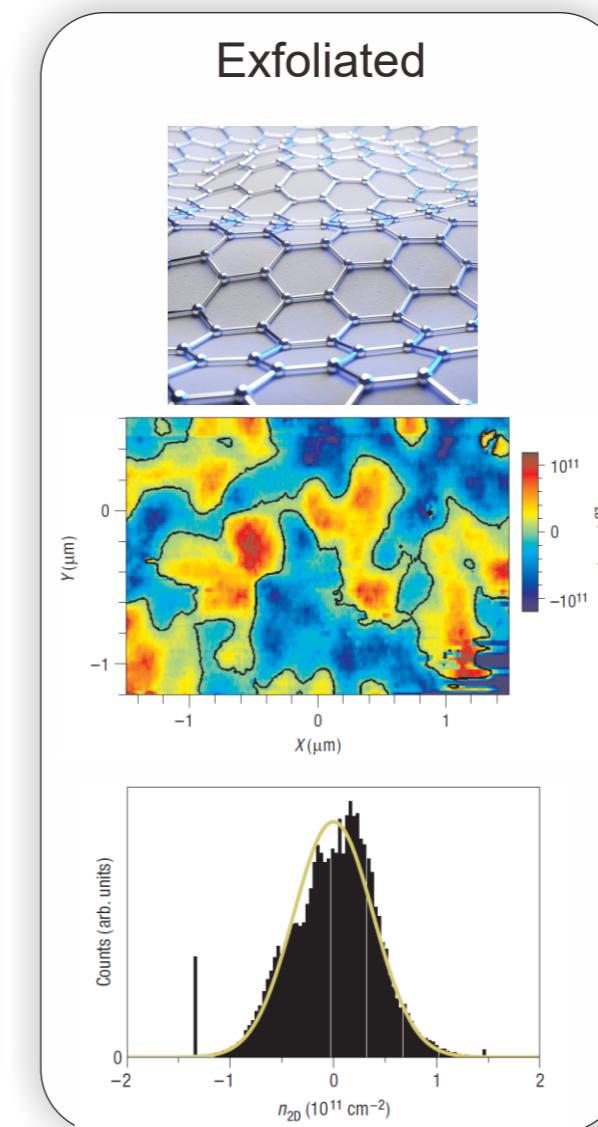
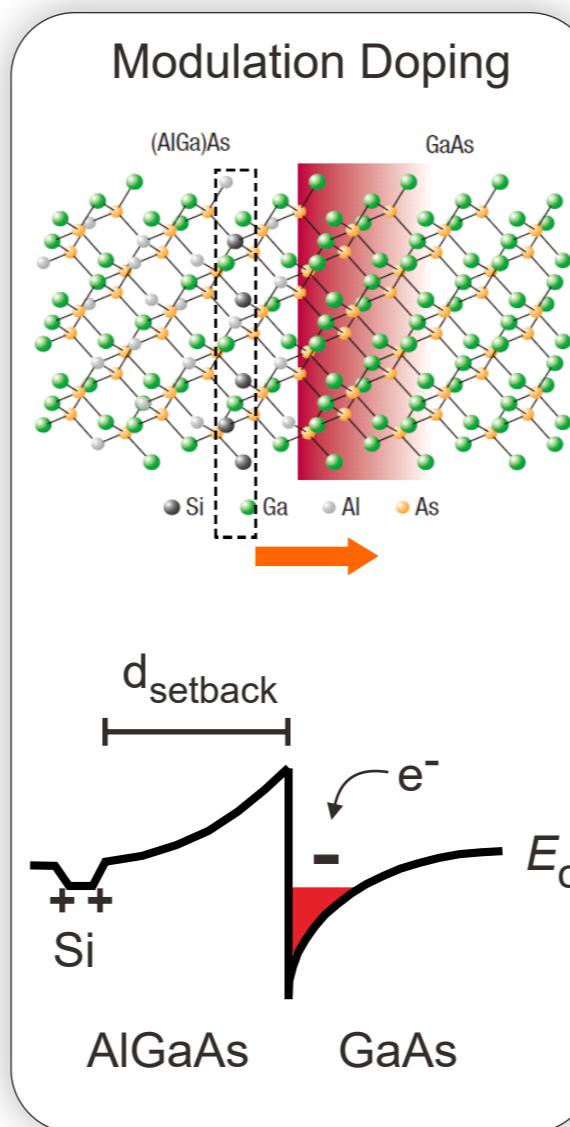
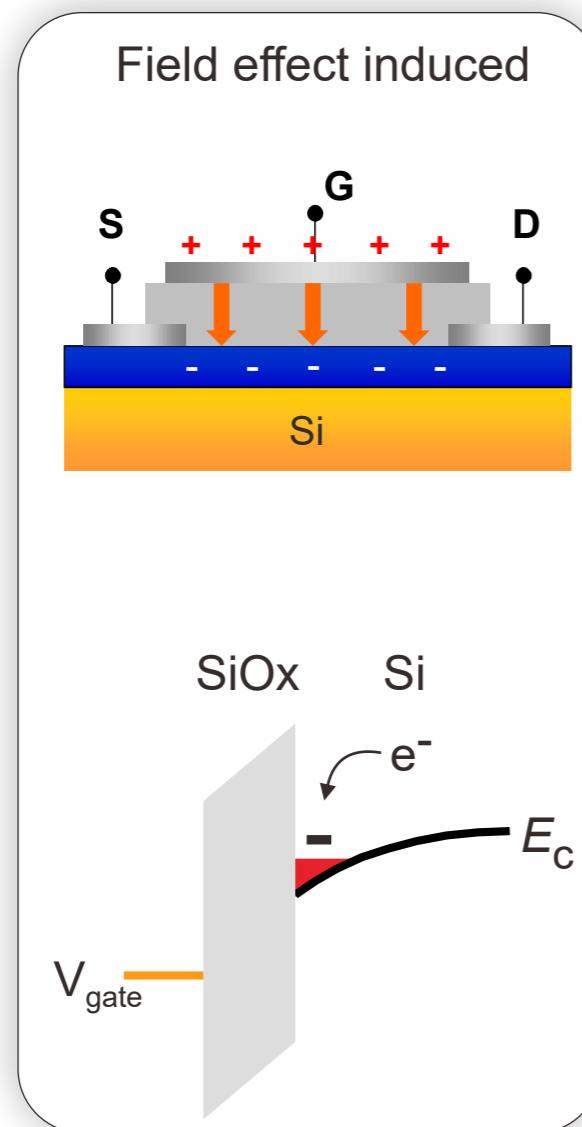
Nakahara, et al., *Appl. Phys. Lett.*
 97, 013501 (2010)

12



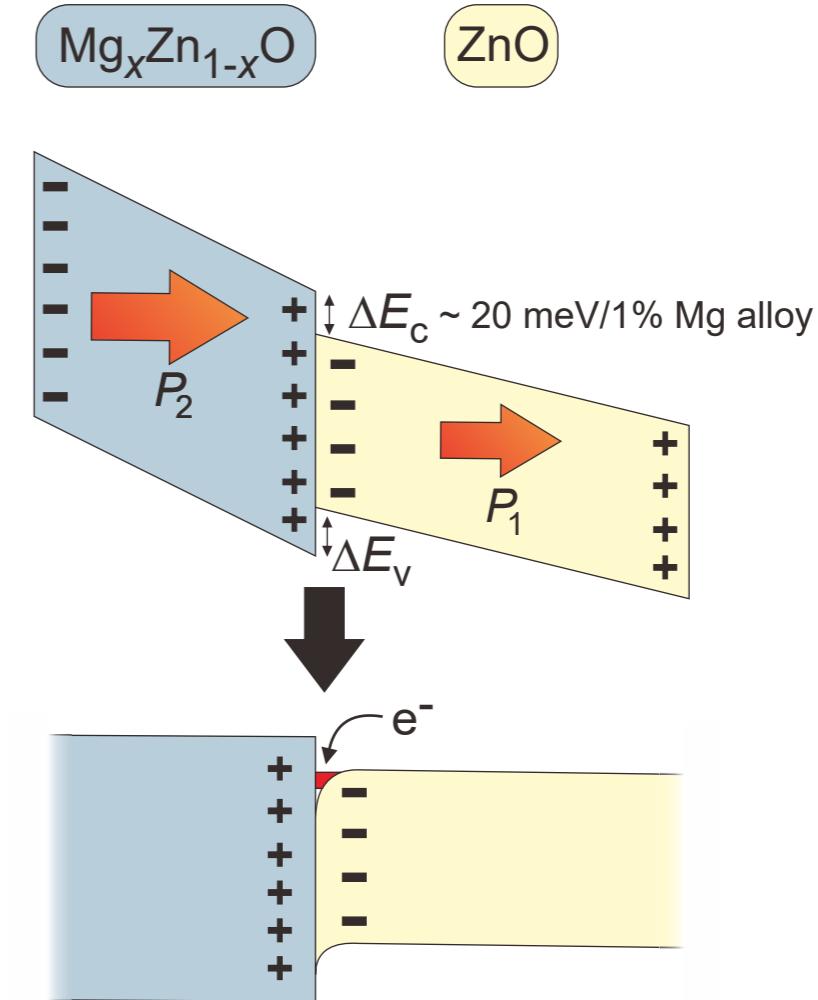
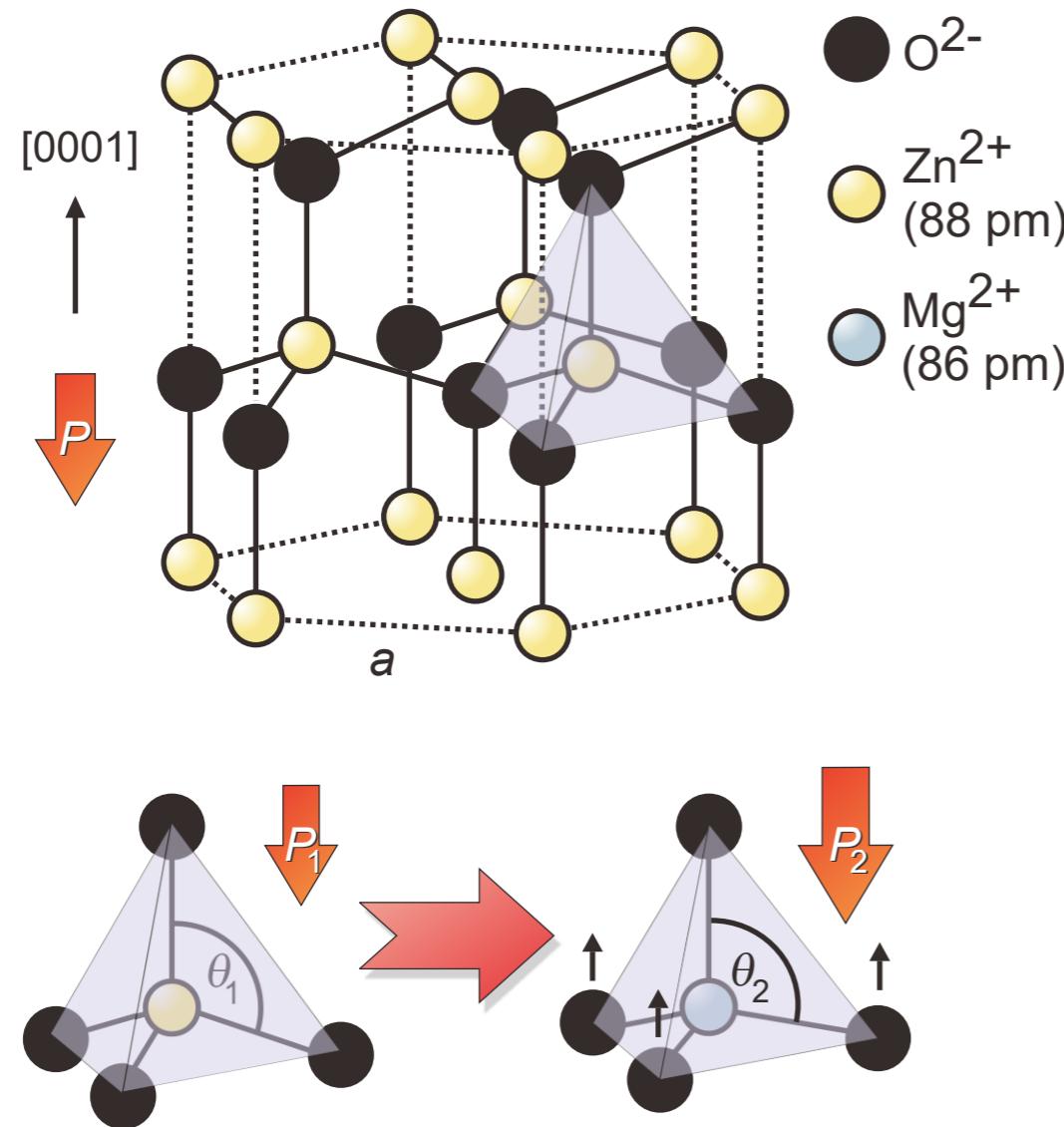
Electrons in a two-dimensional world

13

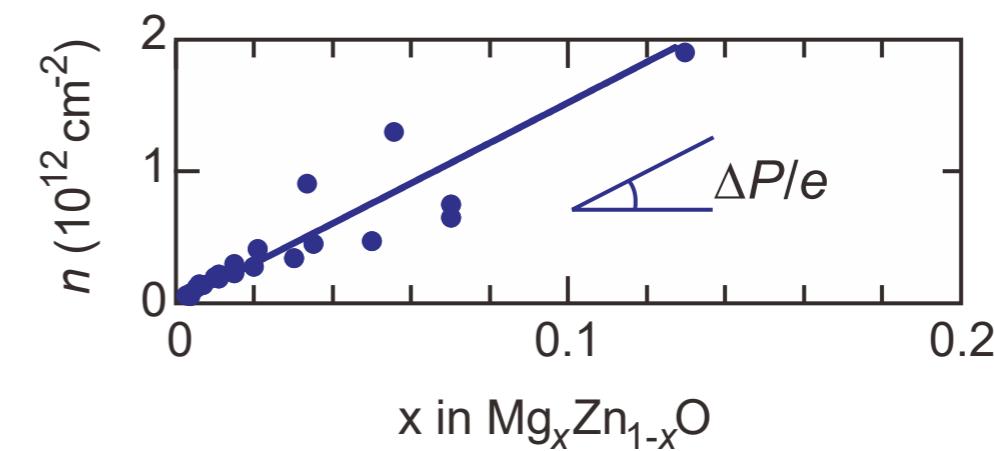
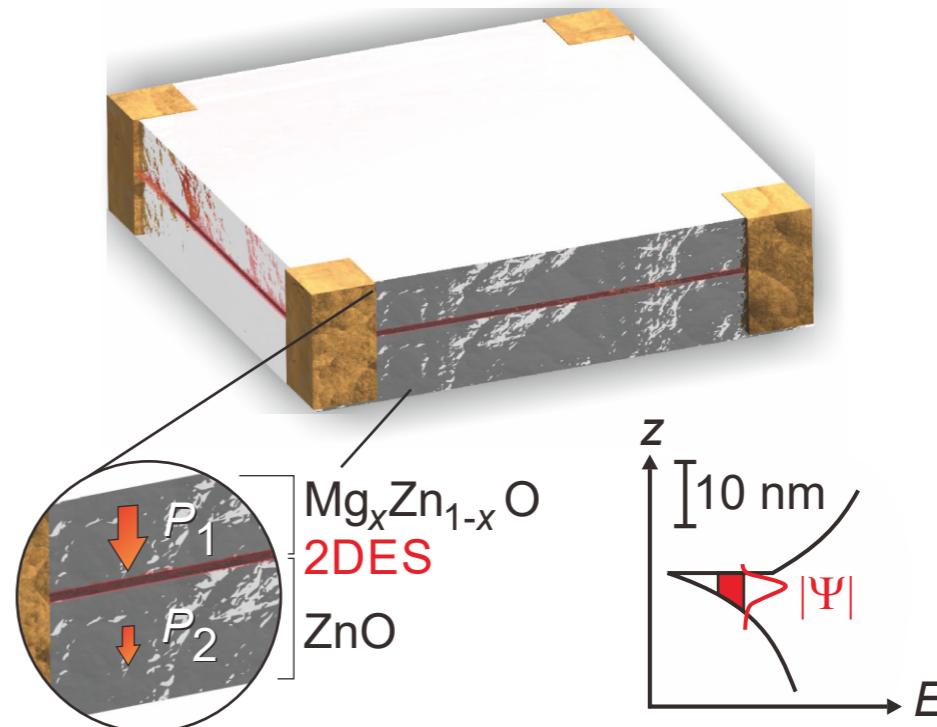
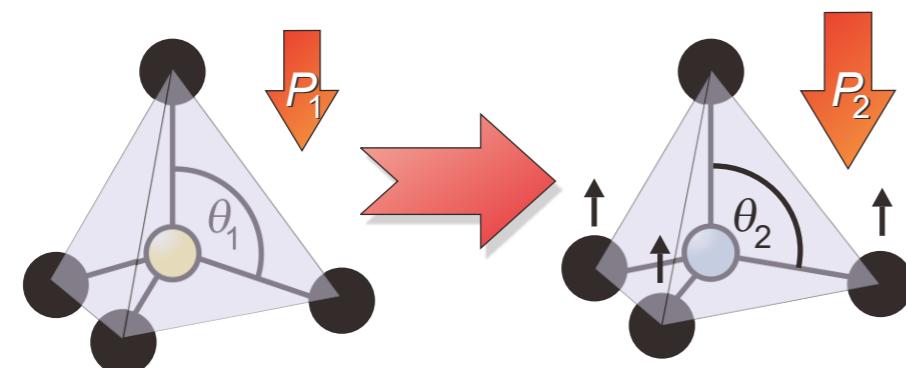
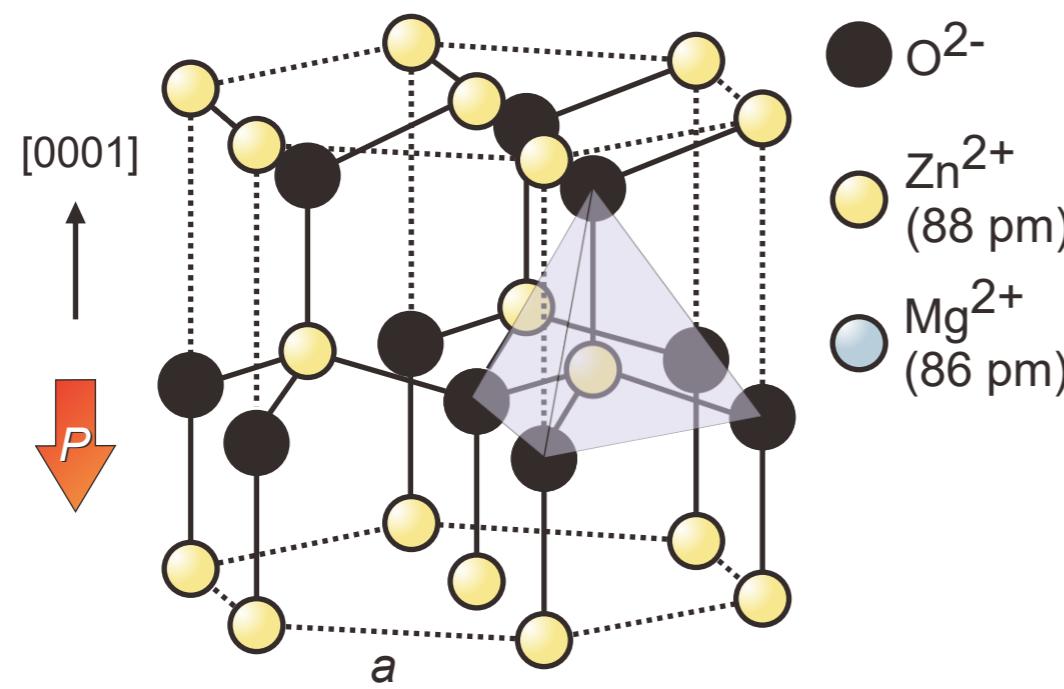


The king: Modulation doped GaAs

ZnO two-dimensional electron system



ZnO two-dimensional electron system



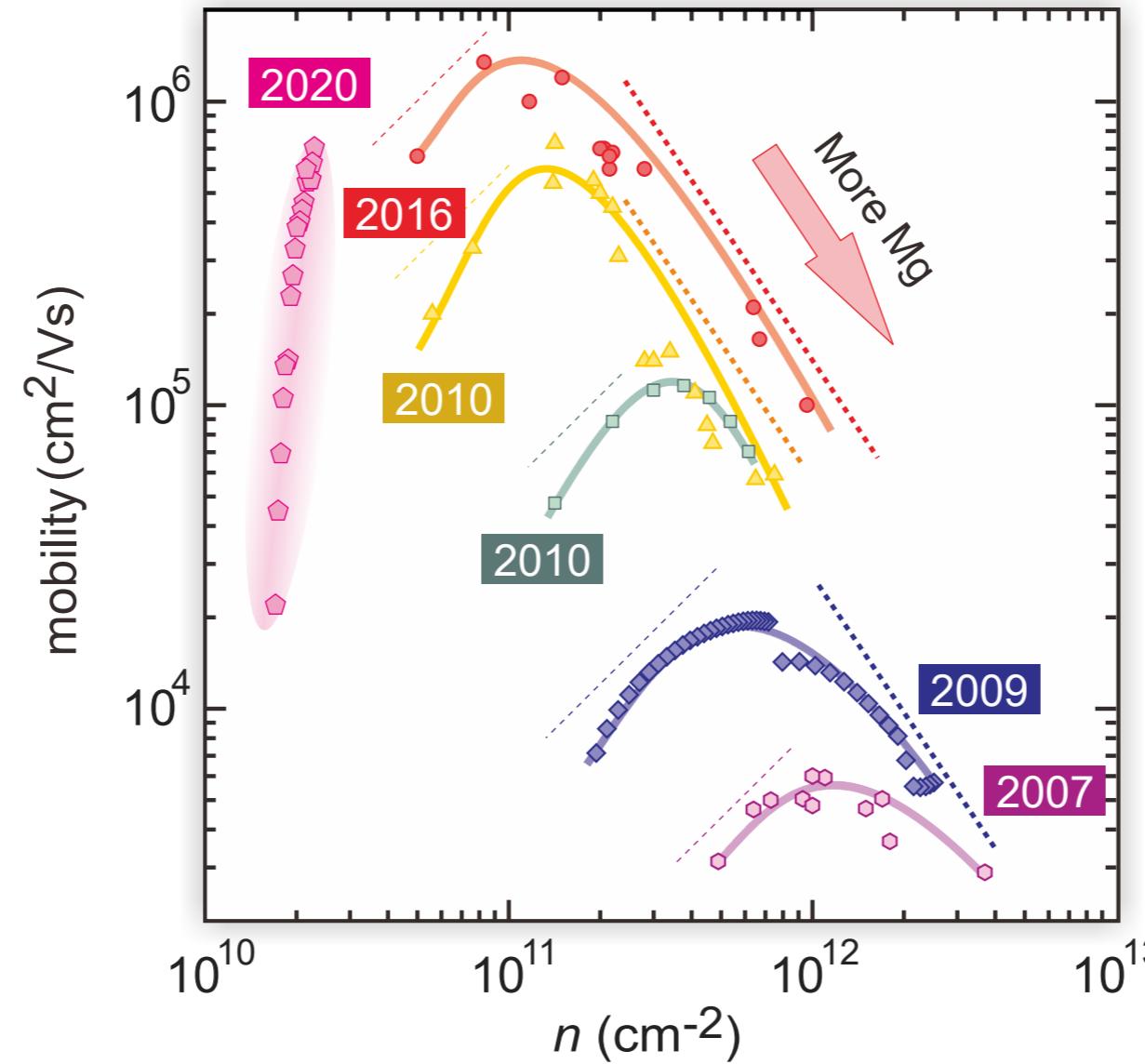
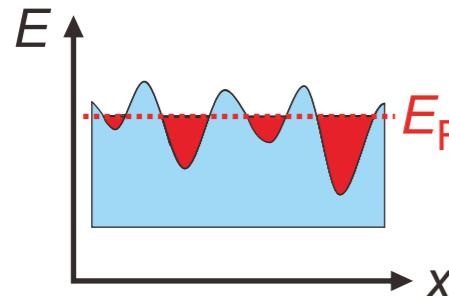
Record electron mobility

JF, et al., Scientific Reports **6**, 26598 (2016)

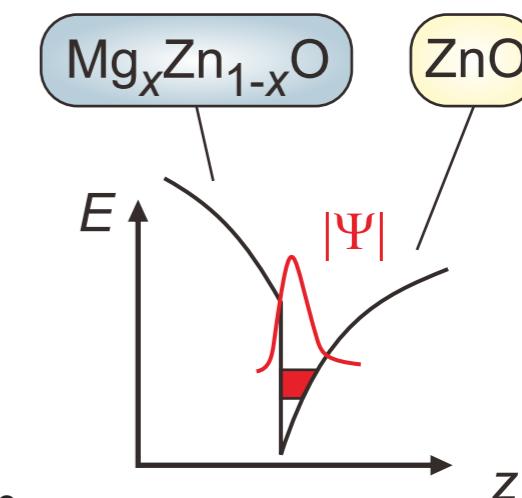
JF and M. Kawasaki., Rep. Prog. Phys **81**, 056501 (2018).

17

- Screening enhanced as E_F ($=n$) is increased



- Interface made rougher, wave-function pushed to interface as Mg is increased



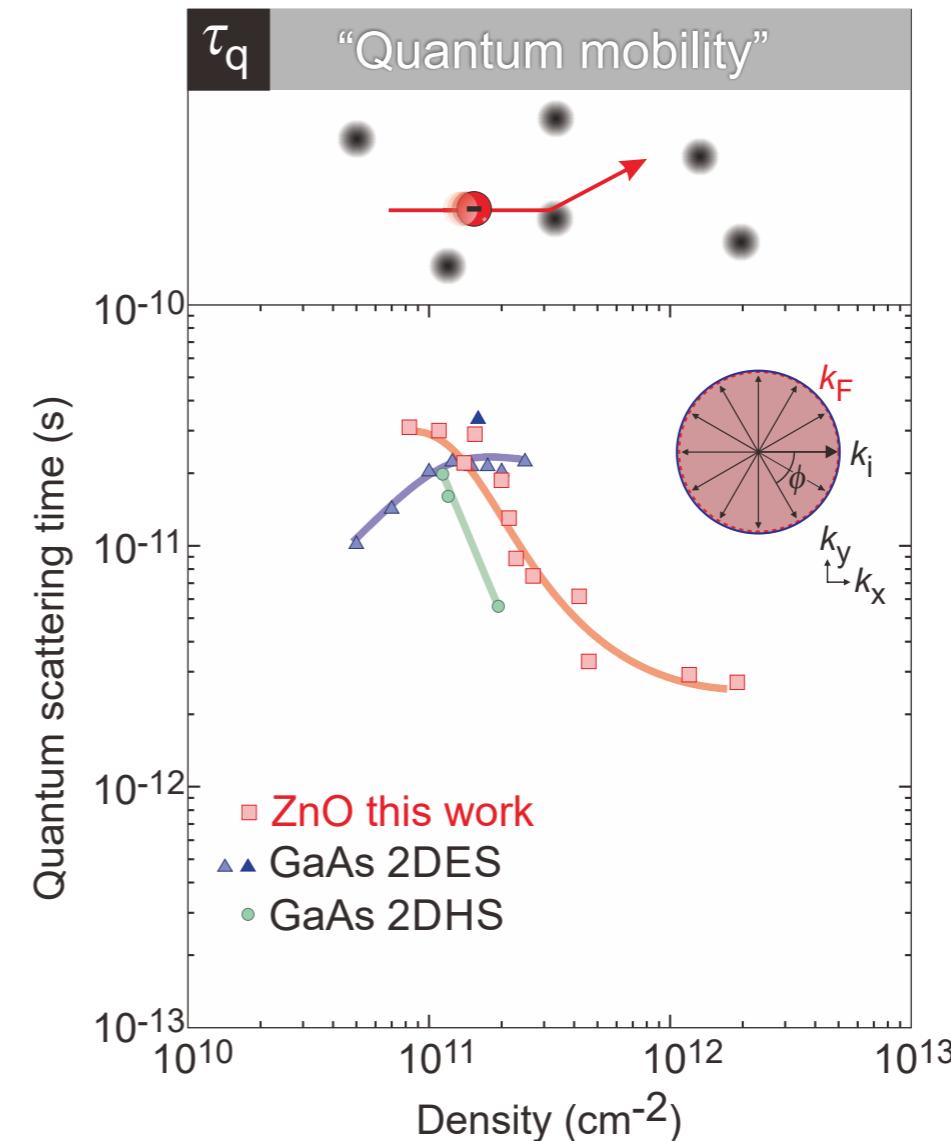
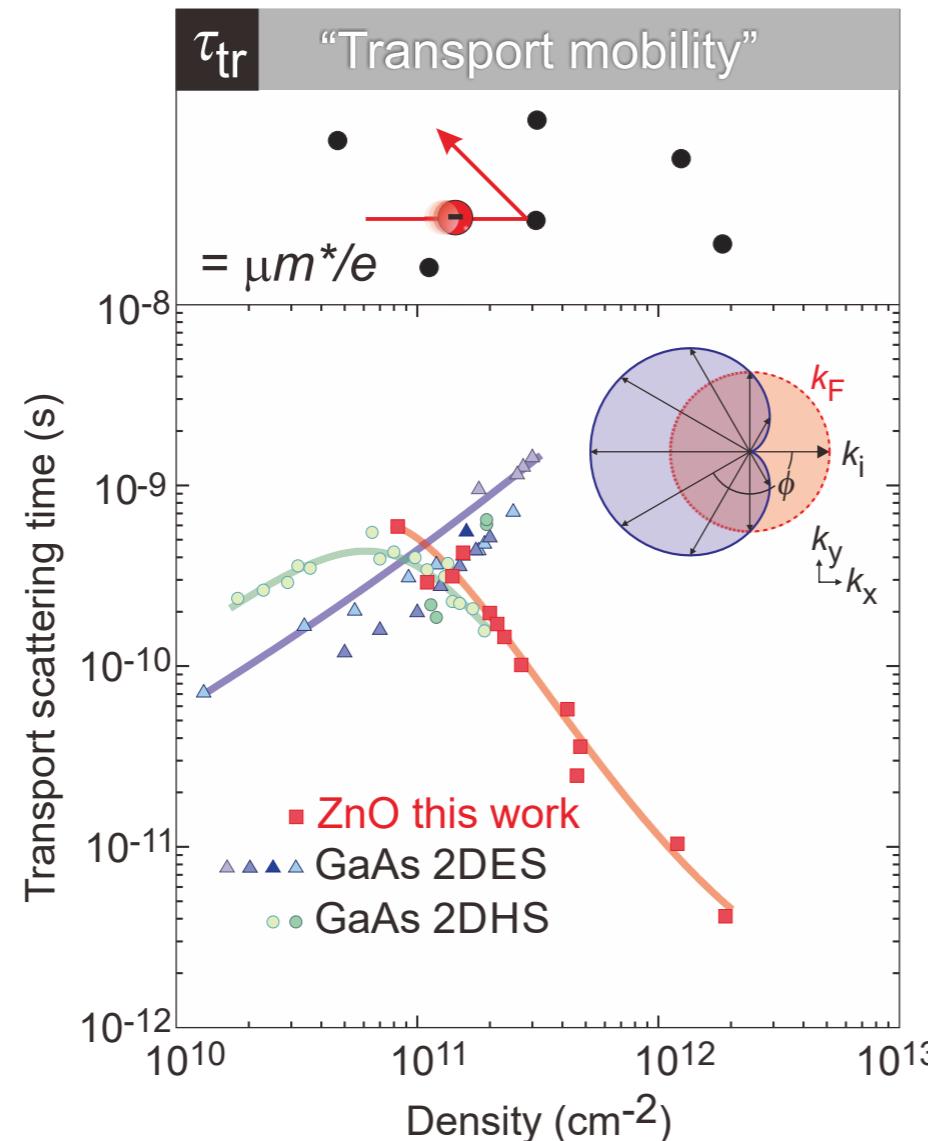
Electron scattering times

JF, et al.,
Appl. Phys. Lett. 107, 082102 (2015).

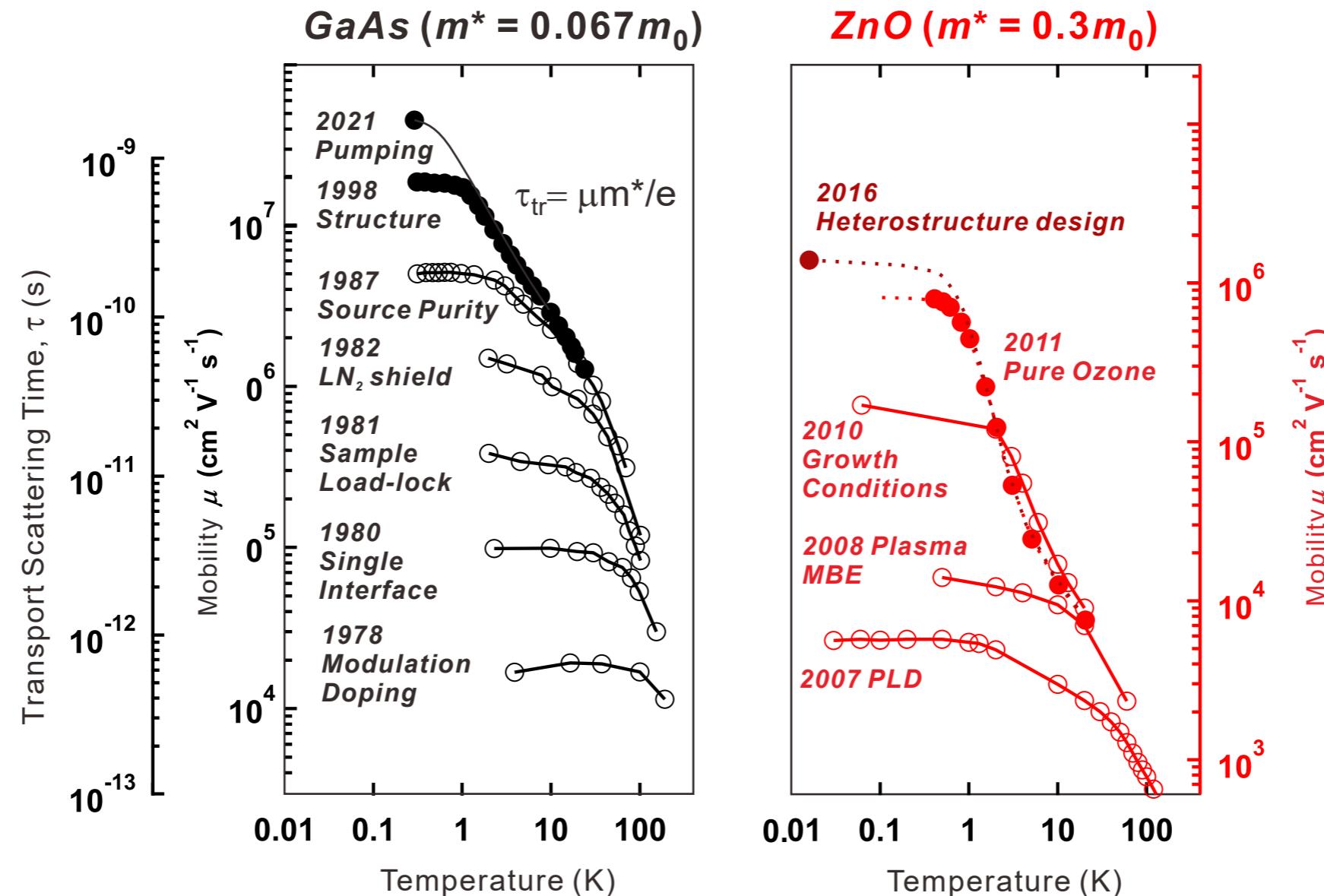
18

$$\frac{1}{\tau_{\text{TR}}(\epsilon)} \equiv \Omega \int \frac{d^3 \vec{k}'}{(2\pi)^3} W_{\vec{k}\vec{k}'} (1 - \cos \theta_{\vec{k}\vec{k}'}),$$

$$W_{\vec{k}'\vec{k}} = \frac{2\pi}{\hbar} |M_{\vec{k}'\vec{k}}|^2 \delta(\epsilon_{\vec{k}'} - \epsilon_{\vec{k}})$$

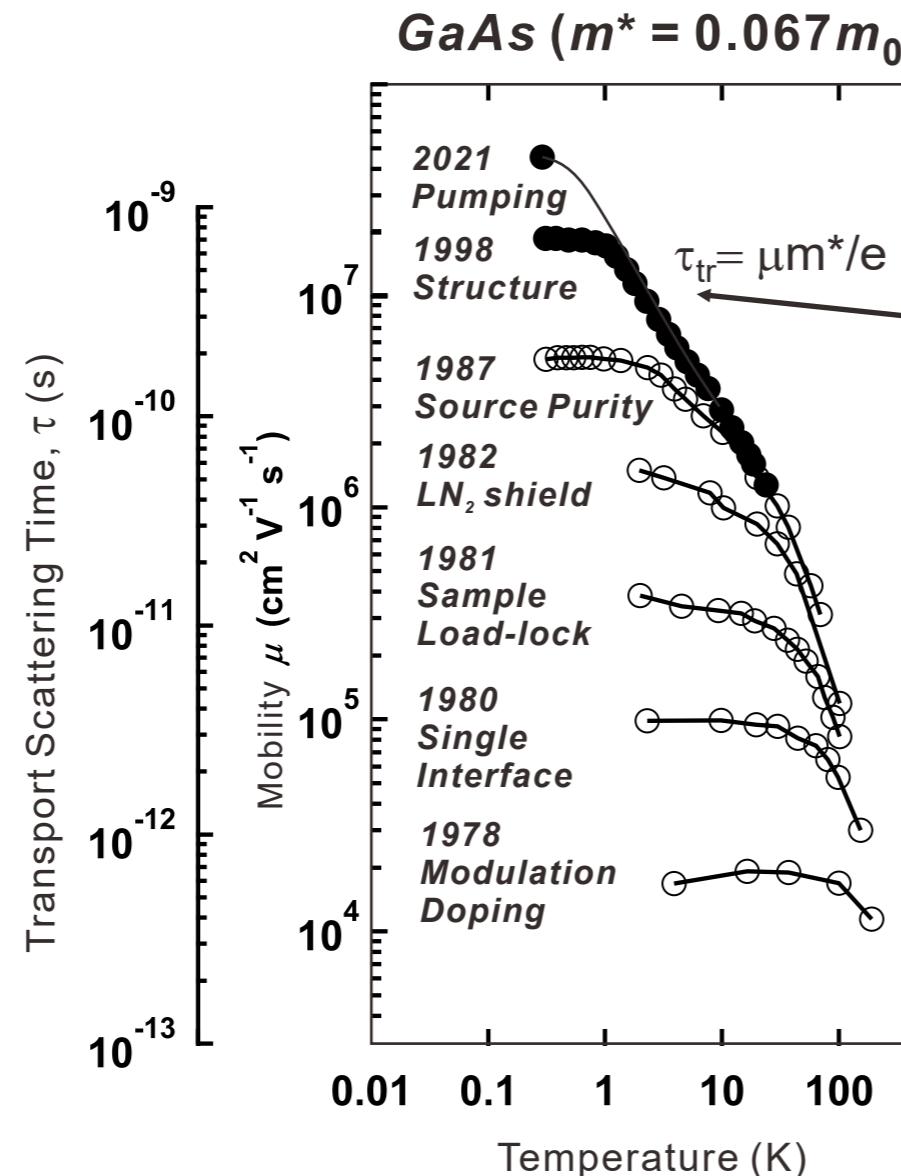


vs. GaAs 2DEG

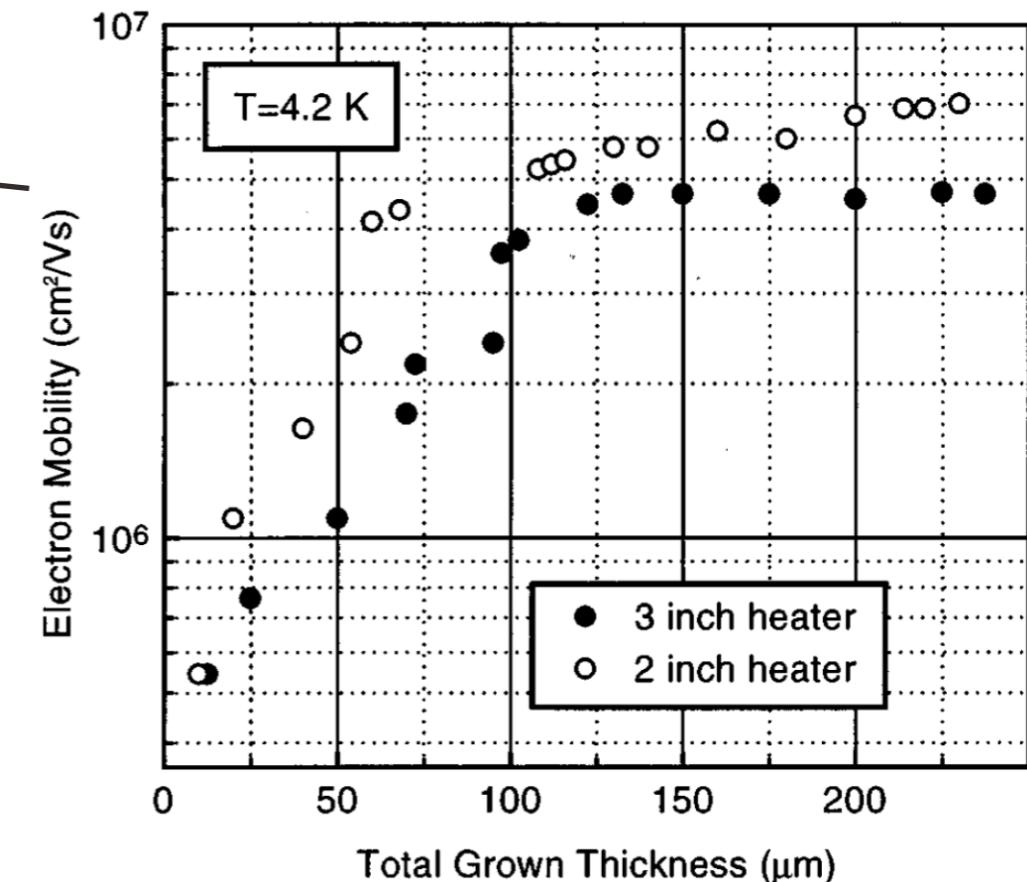


D. Schlot and L. Pfieffer, *Nature Materials* **9**, 881 (2010).
 L.N. Pfeiffer, et al., *Nature Materials* **20**, 632 (2021)

One step in the GaAs road



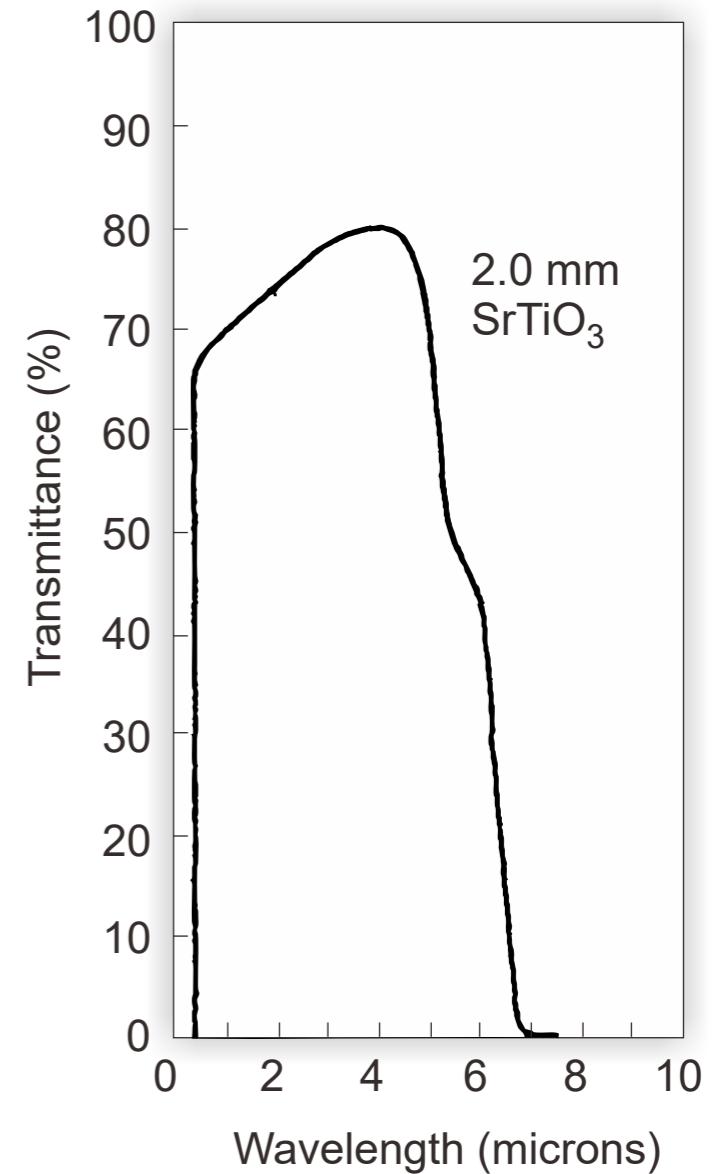
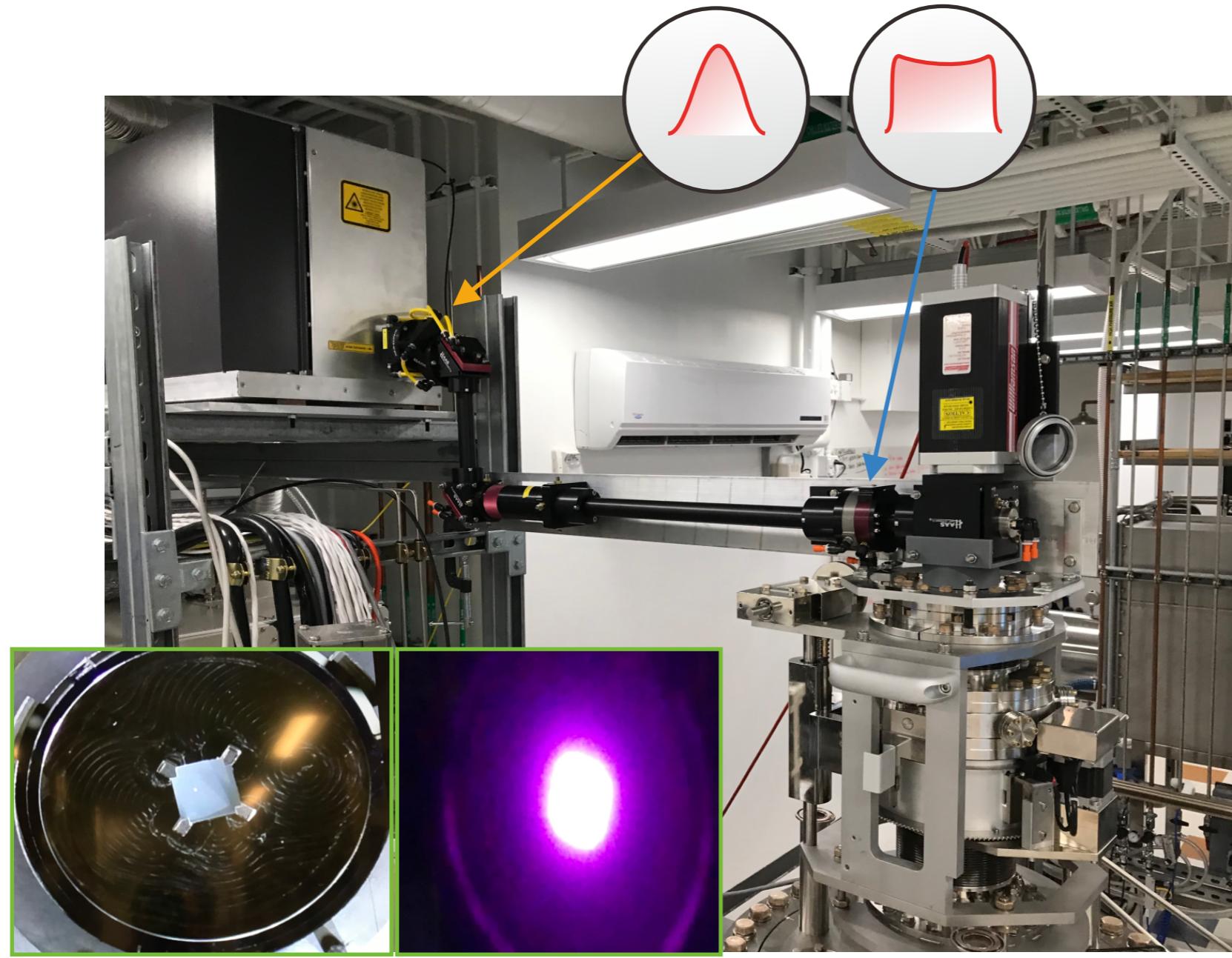
V. Umansky, et al., Appl. Phys. Lett. 71, 683 (1997).



The future is laser-based

APL Materials 8, 071112 (2020)

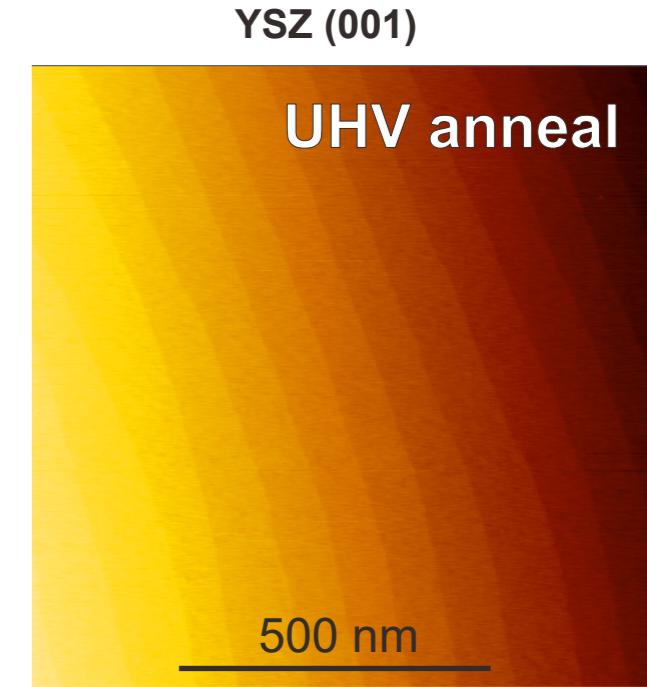
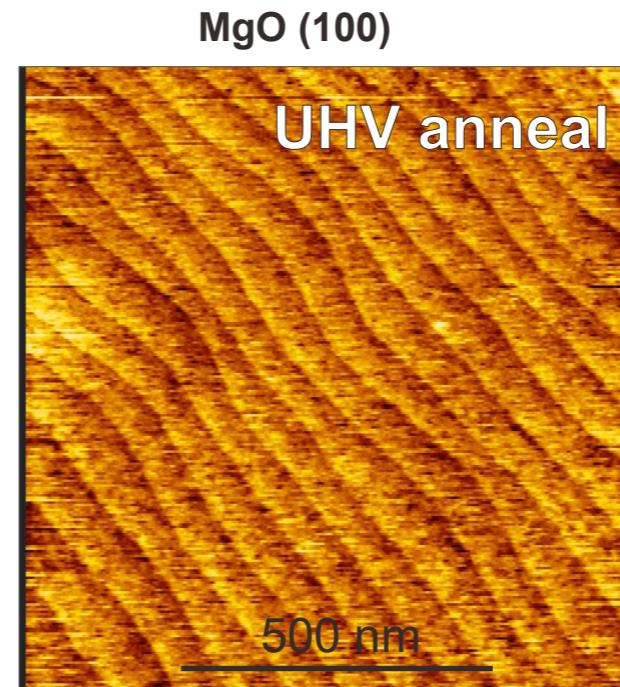
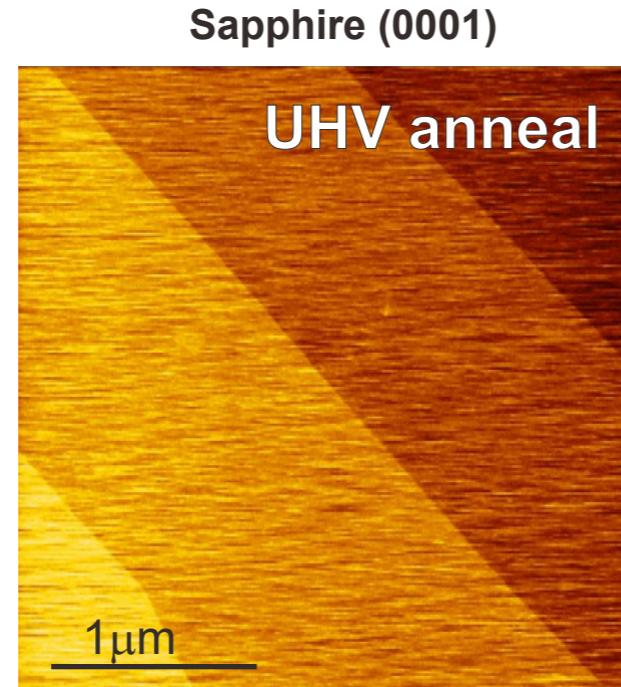
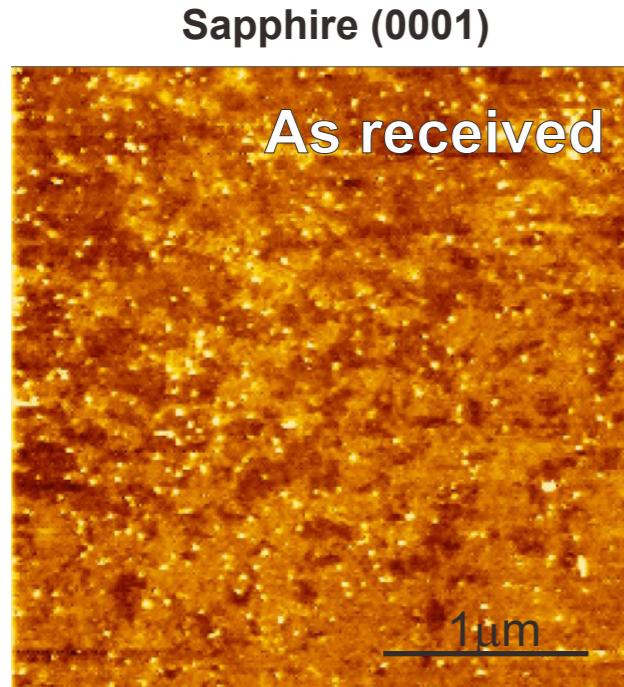
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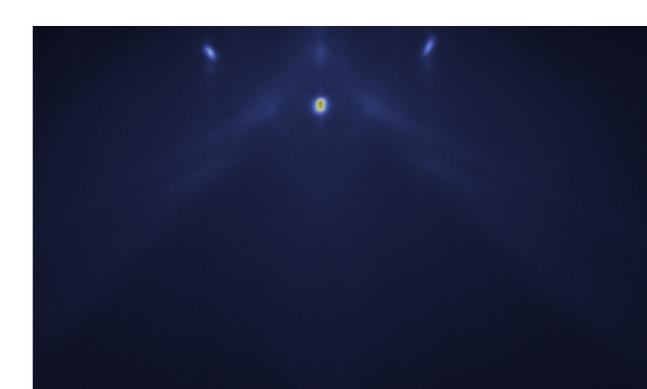
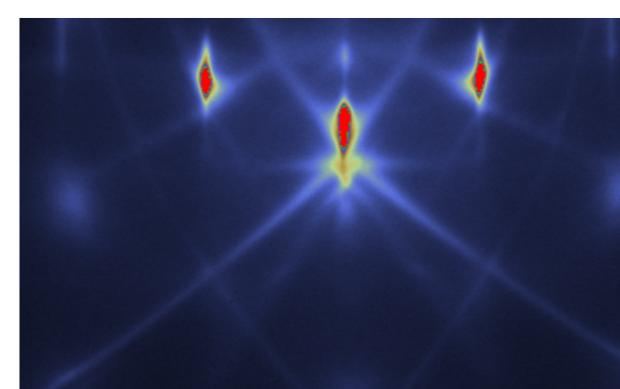
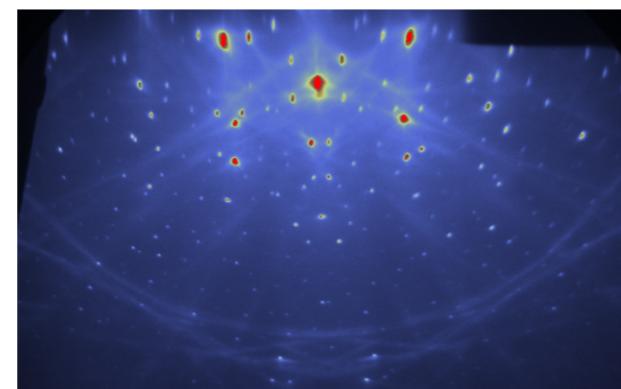
Widely useful for oxides

APL Materials 8, 071112 (2020)

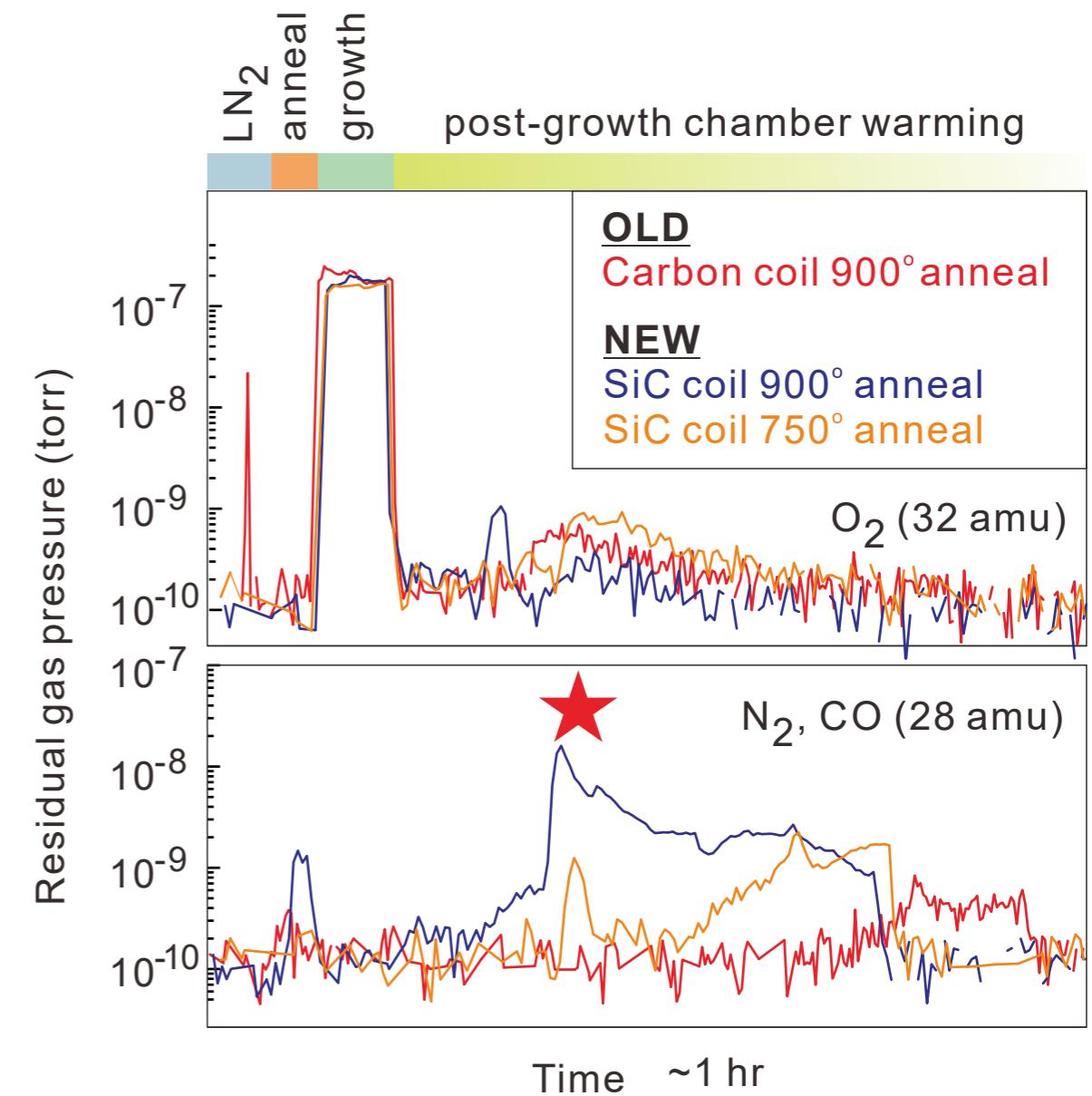
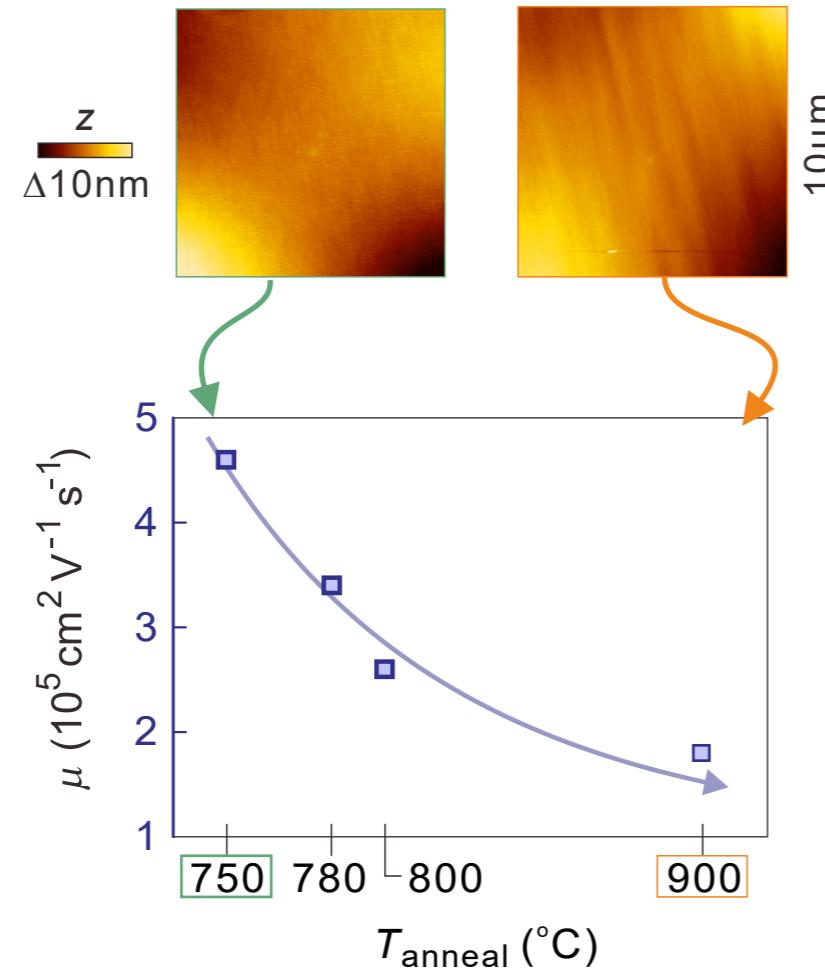
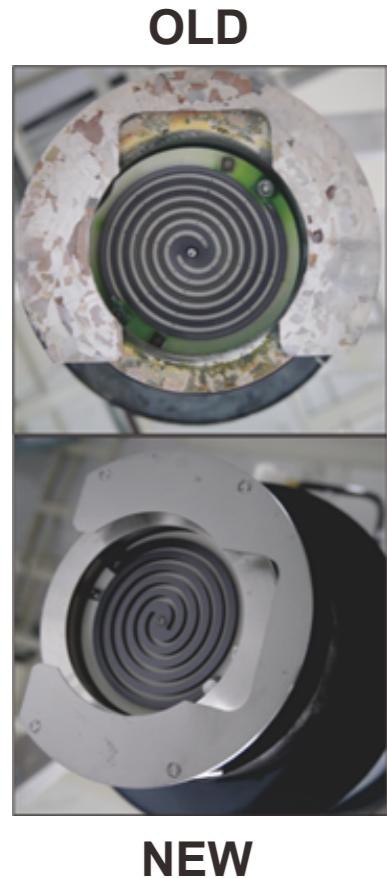
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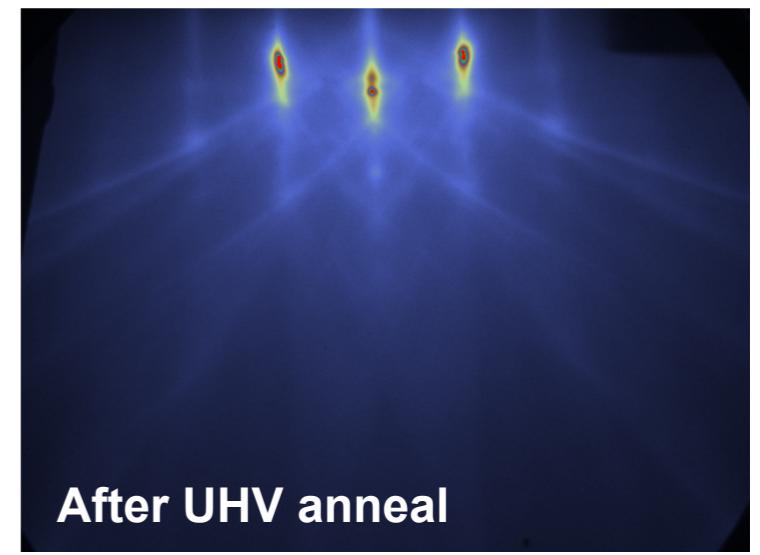
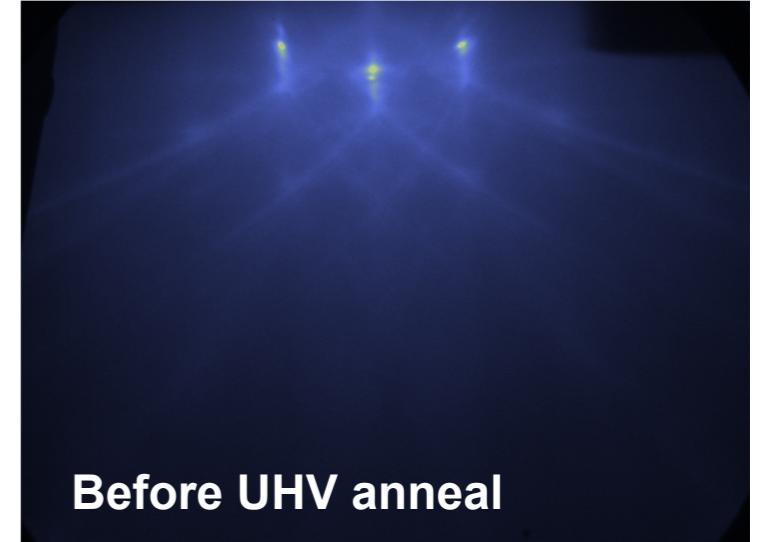
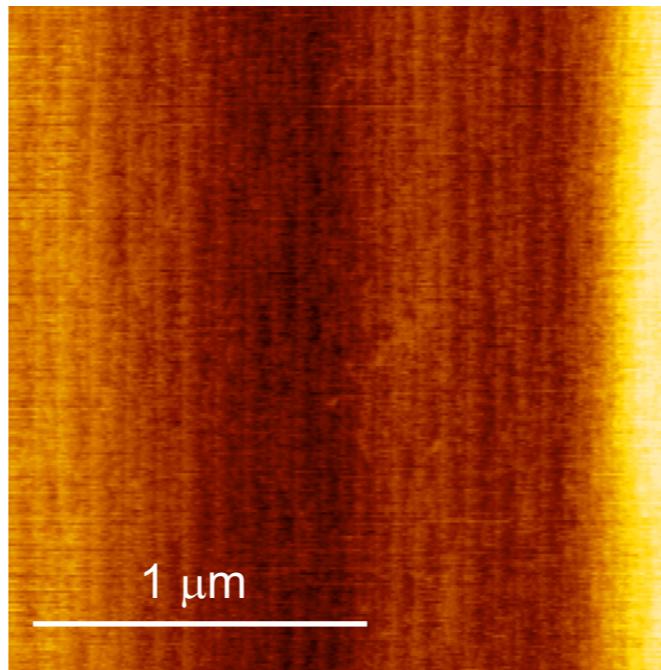
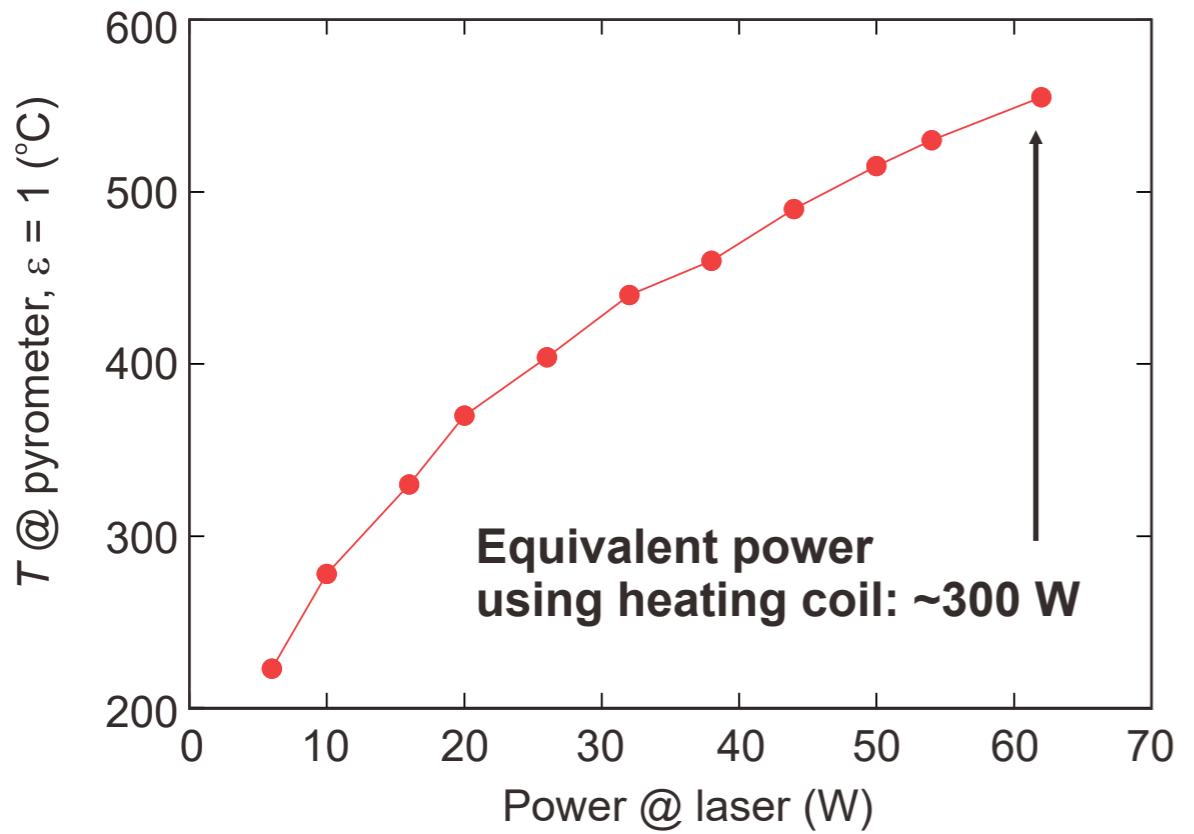
0.77
z (nm)
0



Contamination: Manipulator



Preliminary tests on ZnO



Contamination: Substrate holder

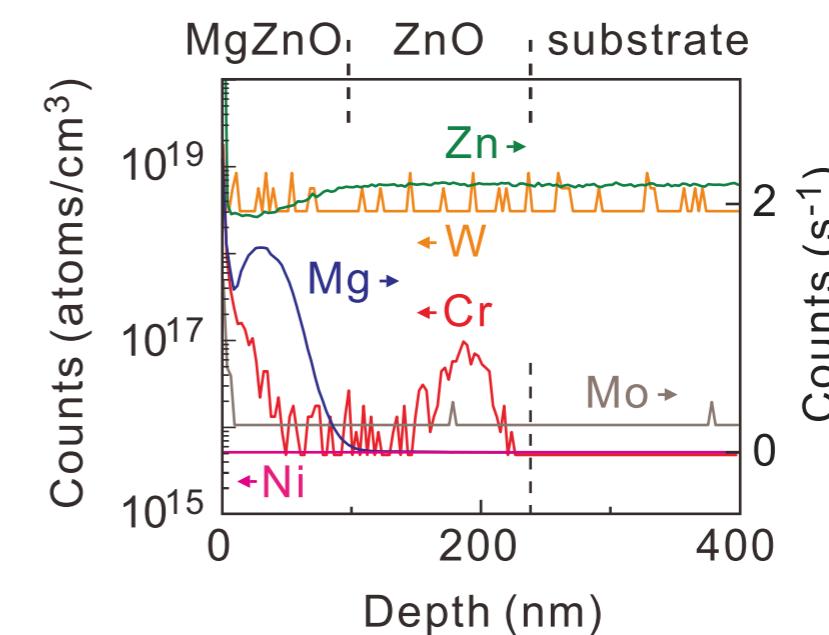
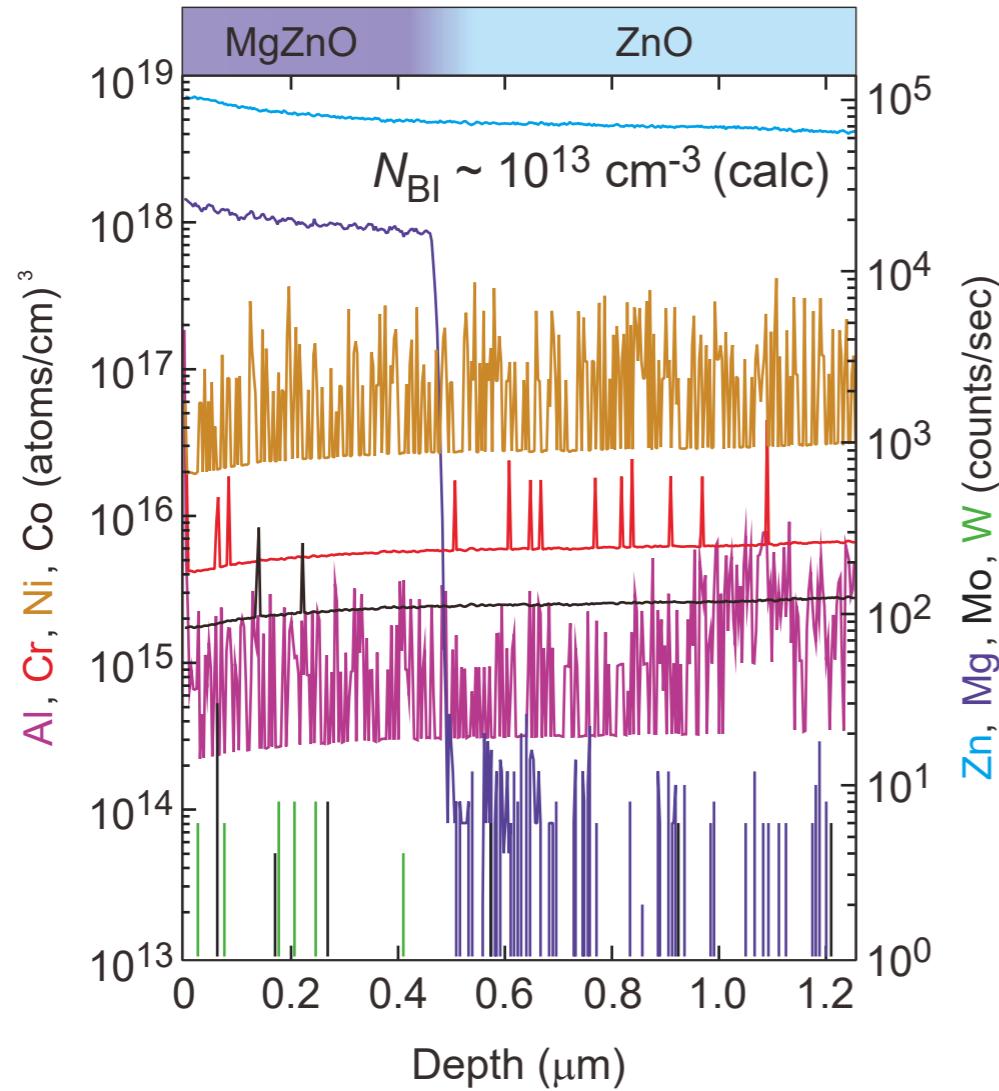
Falson, et al., *Scientific reports* 6, 26598 (2016).

25

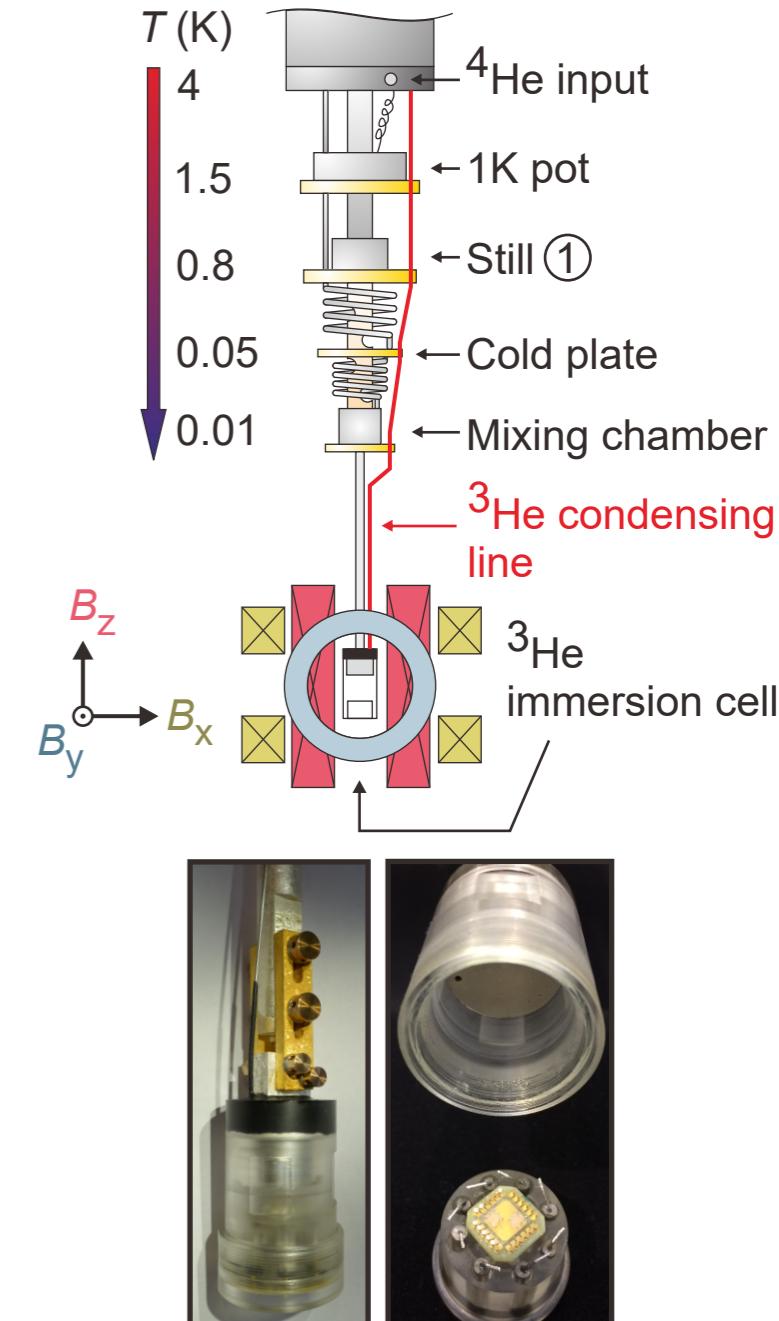
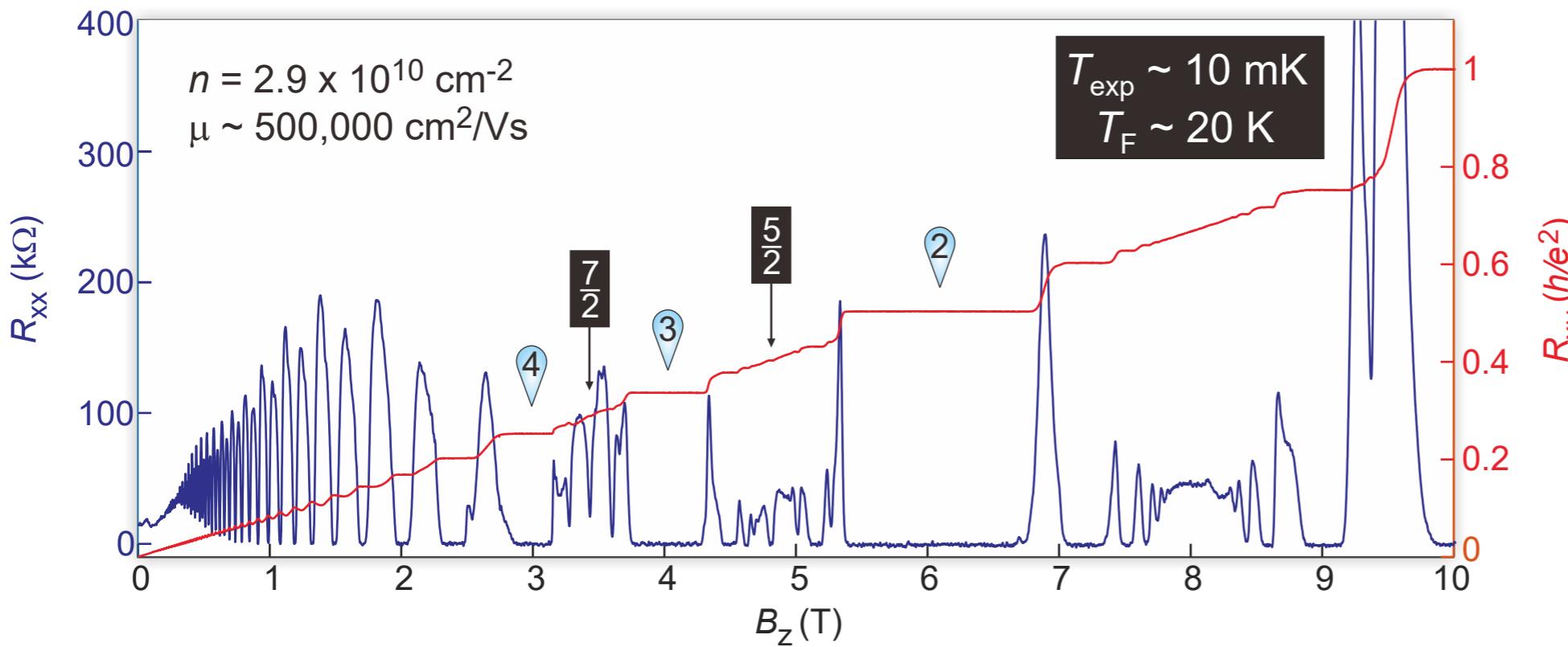
Success

vs

Failure

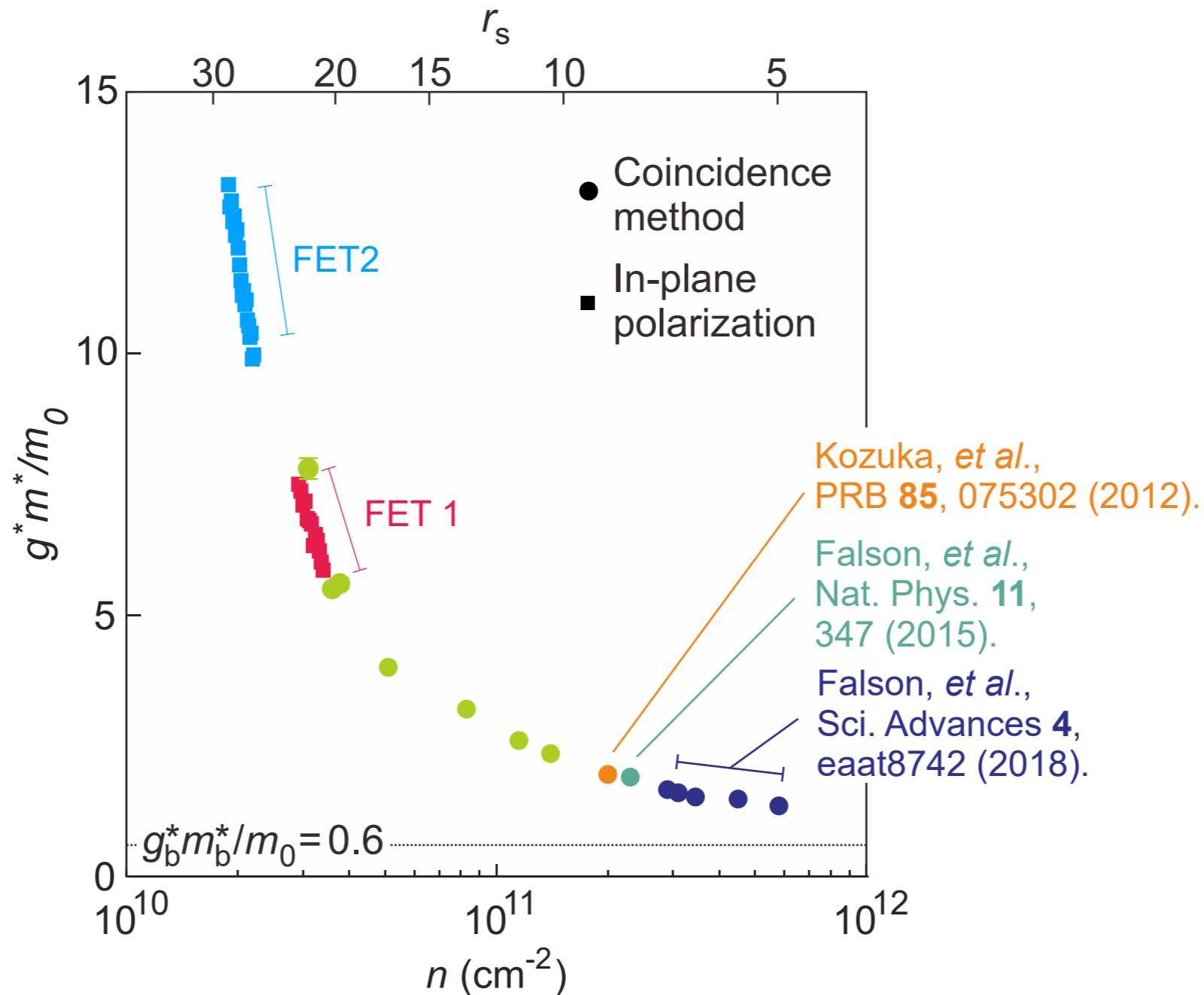


Pushing the limits



Fingerprints of correlation physics

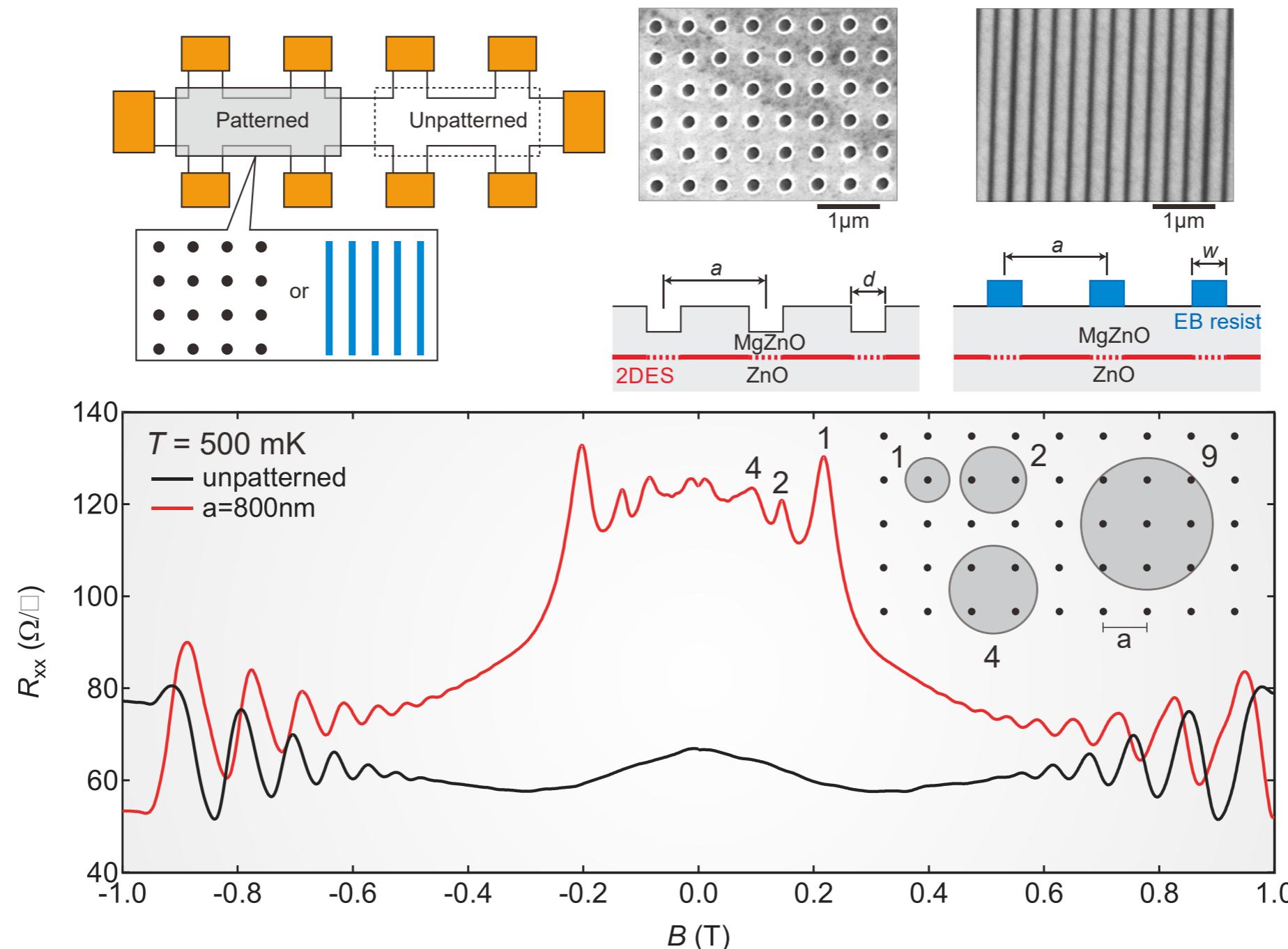
J. Falson, et al.,
Nature Materials **21**, 311 (2022).



Glimpses of mesoscopic physics

K. Tanaka, et al.,
Appl. Phys. Lett. 115, 153101 (2019)

28



Summary & Outlook

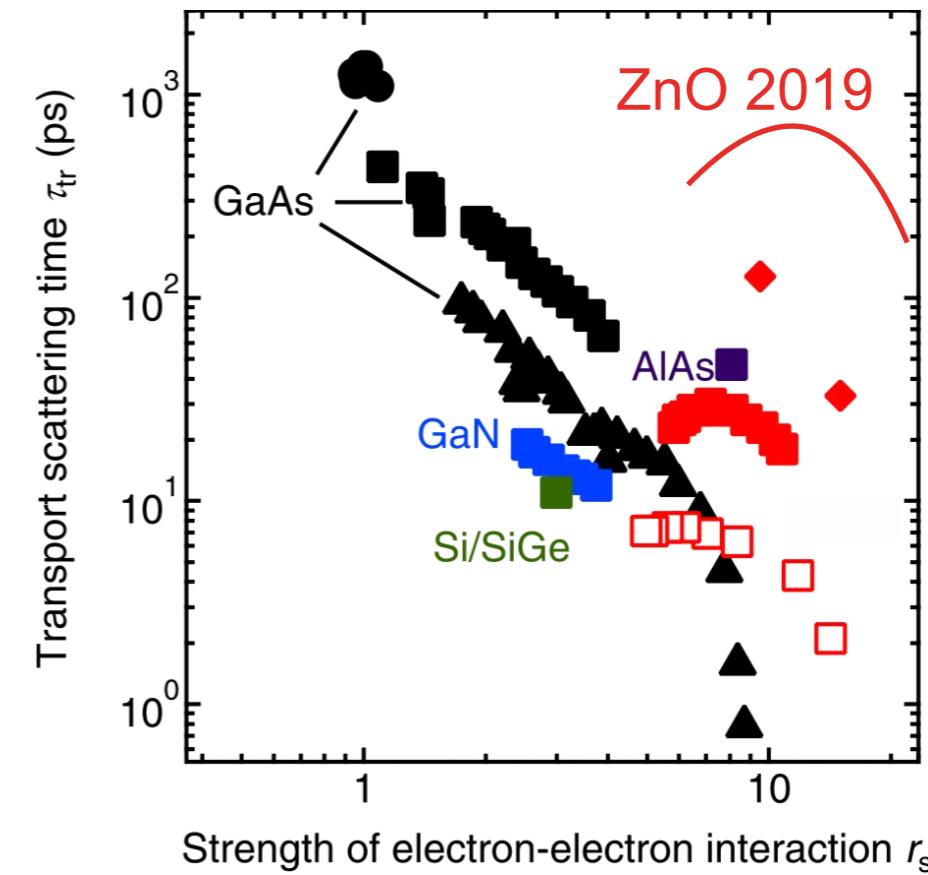
Simple chemistry,
crystallography and device
structure of ZnO enables
pushing the limits of “clean”
oxide MBE

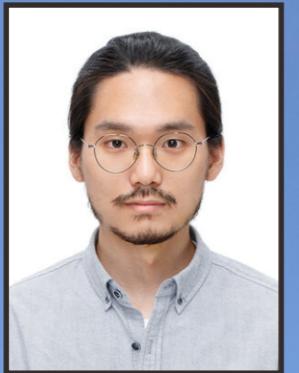
ZnO enters a regime where
electrical transport is
the best means of quantifying
crystallinity

Future challenges of
MBE design refinement
(slow and detailed experiments).
Towards 2(?) million mobility.

Falson, et al., *Nature Physics* 11, 347 (2015),
Falson, et al., *Science Advances* 4,
eaat8742 (2018)),
Falson, et al., *Nature Materials* 21, 311 (2022).

Strongly correlated electron
physics: high mobility meets
quantum criticality

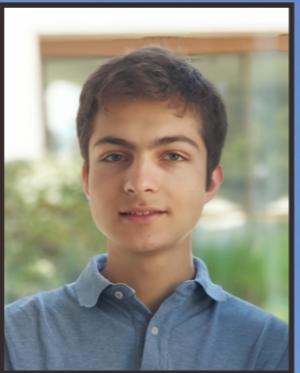




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GORDON AND BETTY
MOORE
FOUNDATION

Thank you

